

BaBar Si Tracker Alignment

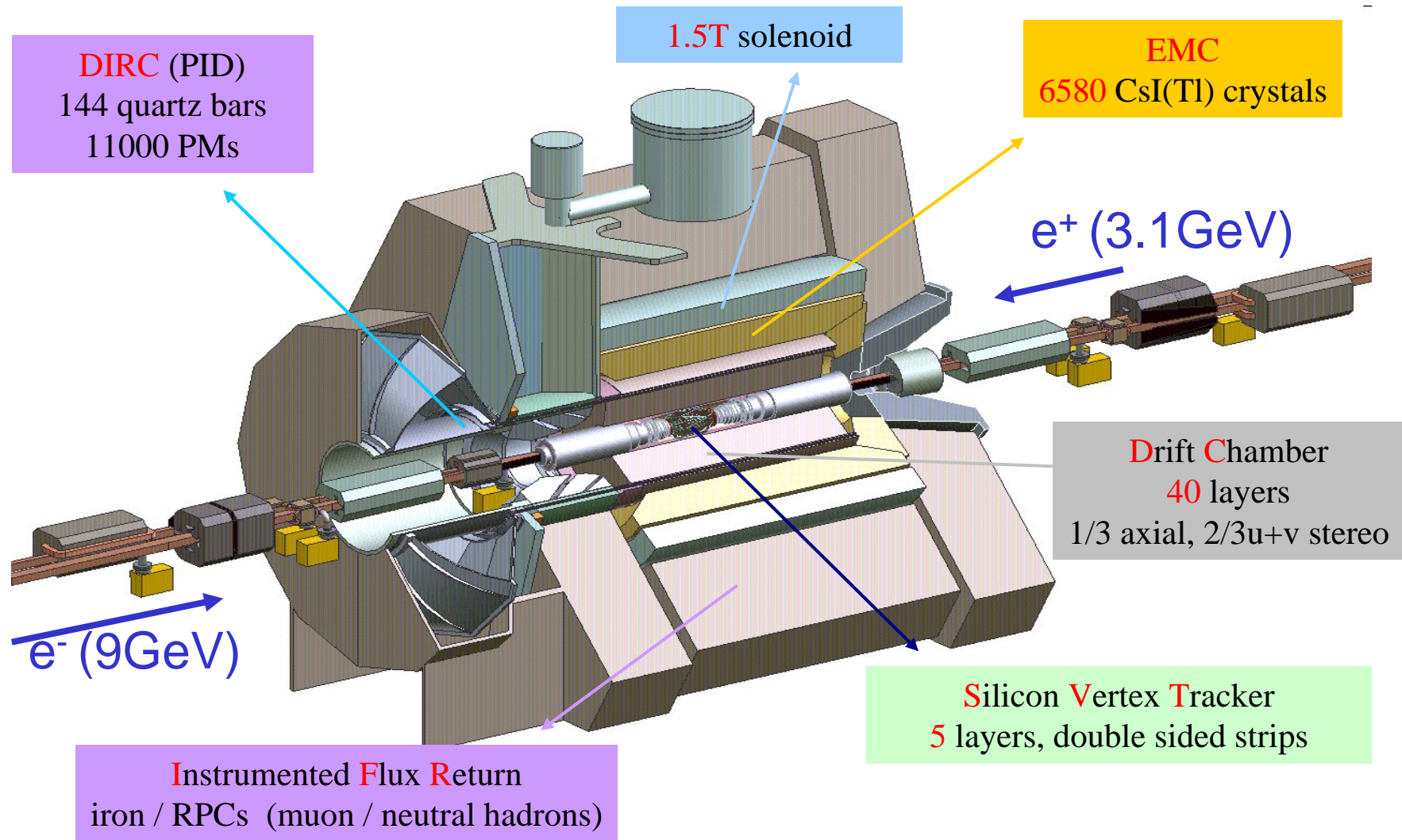
David Nathan Brown, LBNL

Representing the BaBar SVT alignment group

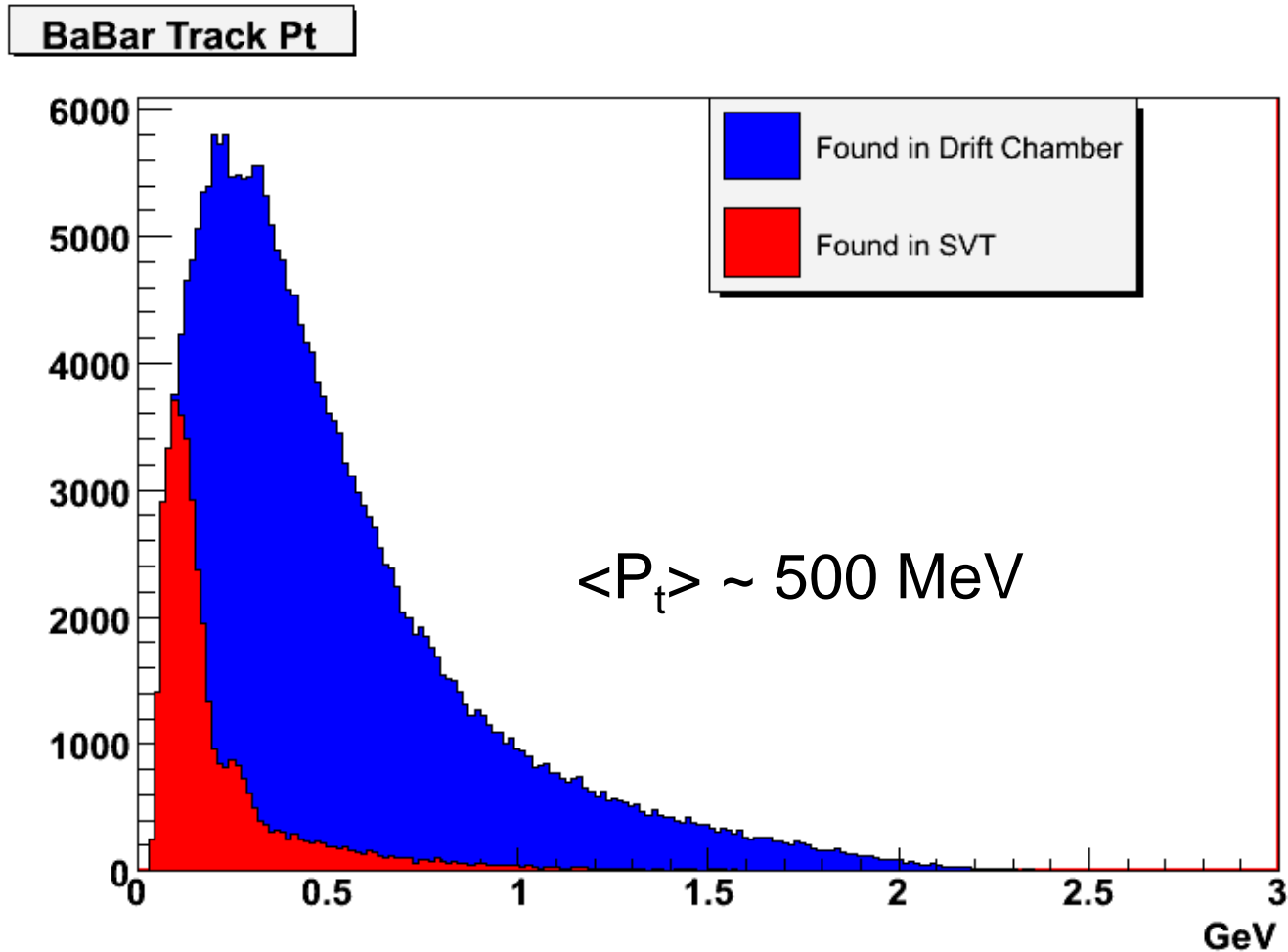
- **The BaBar experiment**
- **The BaBar Si Tracker alignment procedure**
- **Alignment procedure validation**
- **Results**
- **Lessons learned**



PEP-II and BaBar



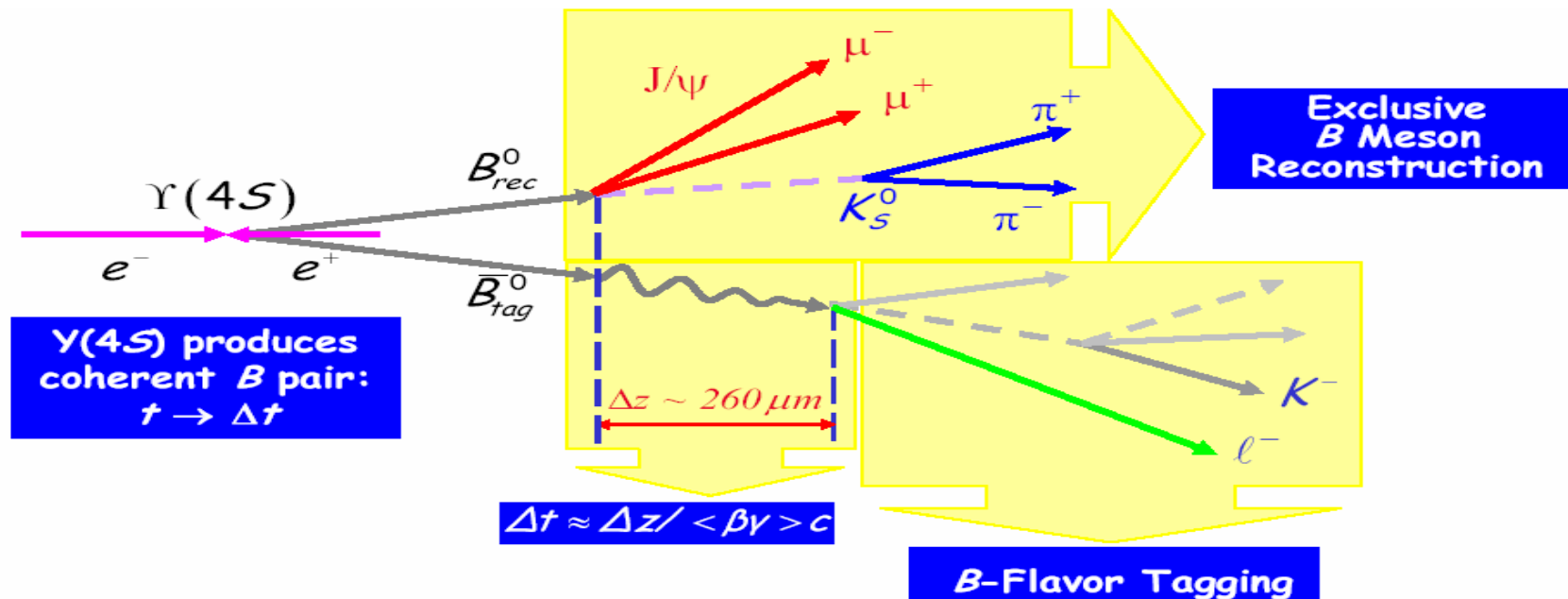
Track Momentum on the $\Upsilon(4S)$



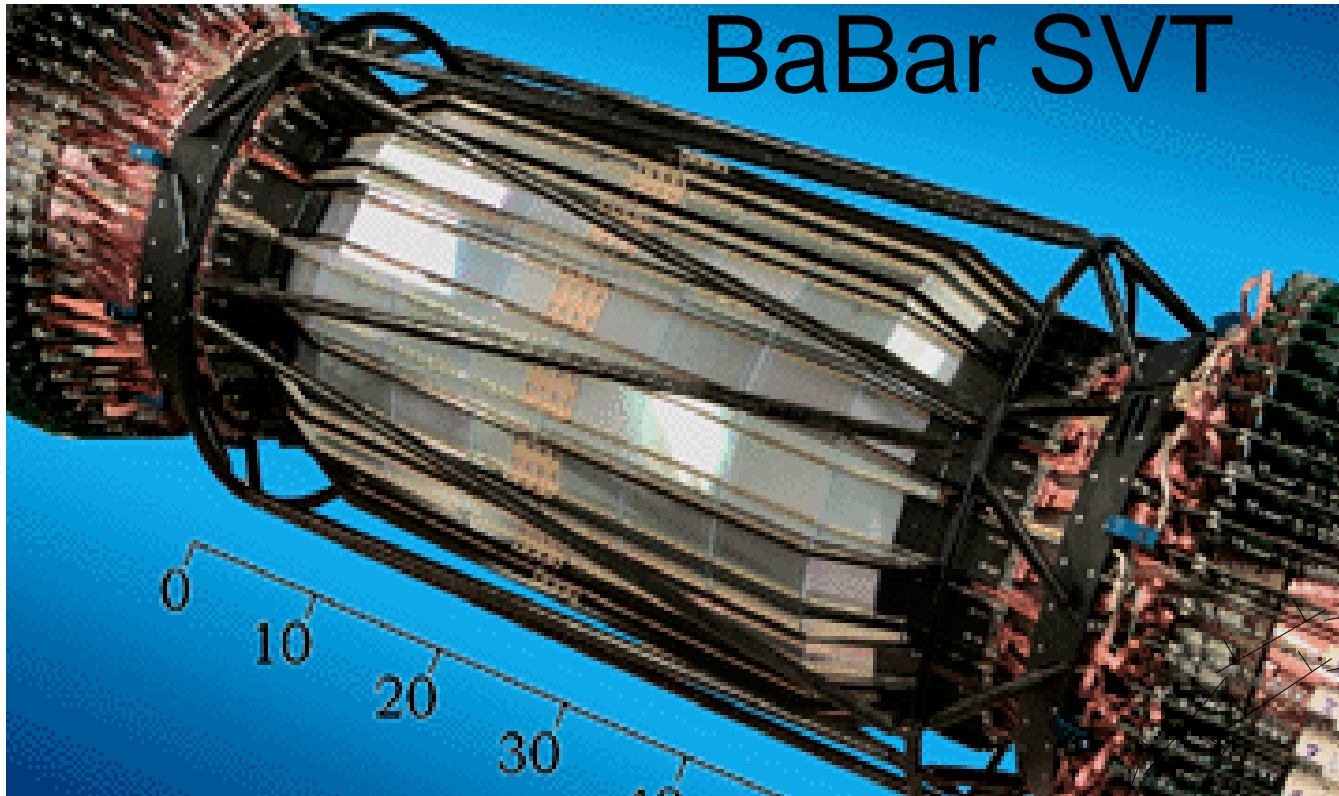
- **Scattering (material) largely dominates over point (hit) resolution in impact parameter resolution**

BaBar Physics Goals

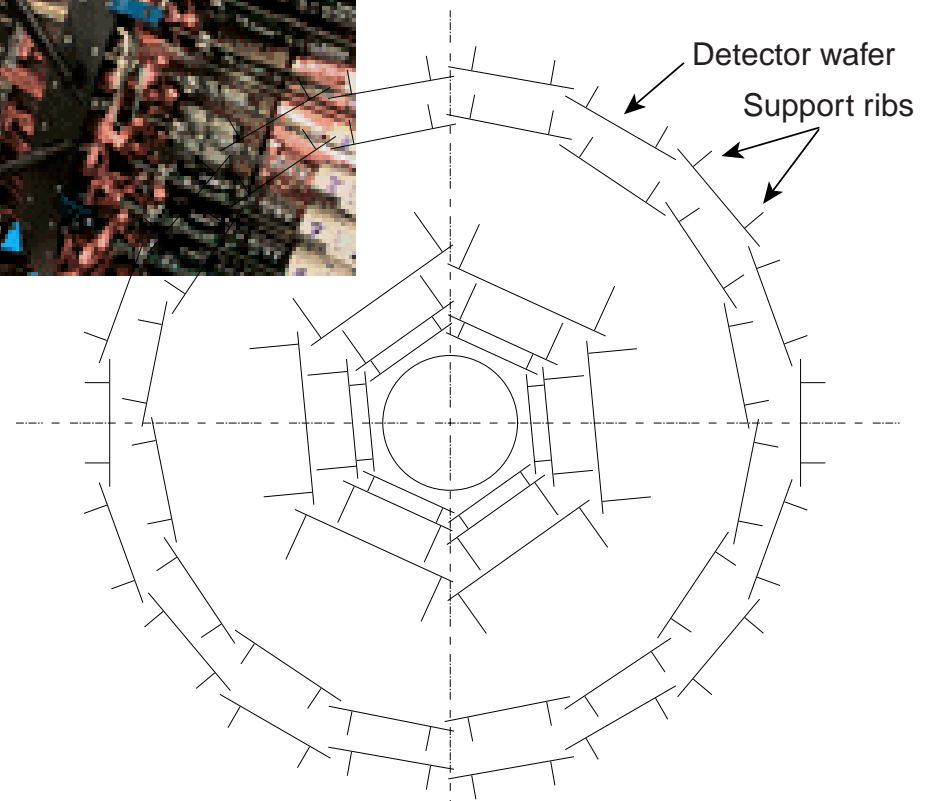
- Observe CP violation in B system
 - ☞ Time-dependent mixing (e.g. $\sin 2\beta$)
 - ☞ $\lambda_z \sim 260 \mu\text{m}$, $\sigma_z \text{ vertex} \sim 180 \mu\text{m}$, \Rightarrow **20 μm point resolution**
- PDG-competitive measurement of B, τ lifetimes
 - ☞ Control **average** alignment systematics to \sim **1 μm** (0.5%)
- No B_s mixing, tertiary charm vertex separation, ...
 - ☞ Modest requirements on material, resolution



BaBar SVT

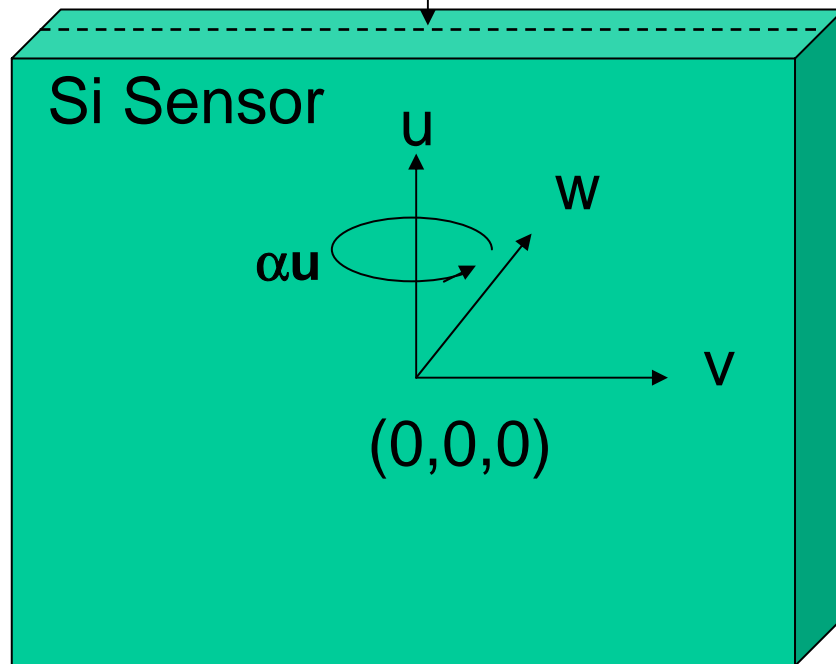


- **5 layers, 340 wafers**
 - ☞ Radii from 3.3 to 15 cm
 - ☞ 'Lampshades' in layers 4 + 5
- **Double sided readout**
 - ☞ 90° strips
 - ☞ Kapton fanouts in active region
- **~2% X_0 total at normal**
 - ☞ 1% X_0 Be beampipe
- **No hardware alignment**

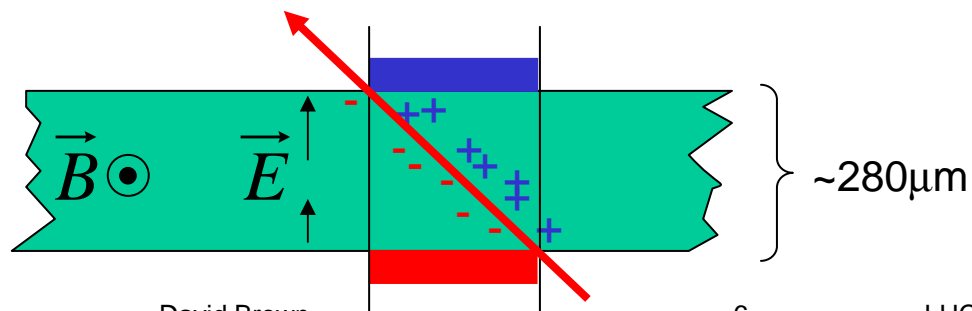


Wafer Alignment Description

Geometric midplane $\equiv w=0$

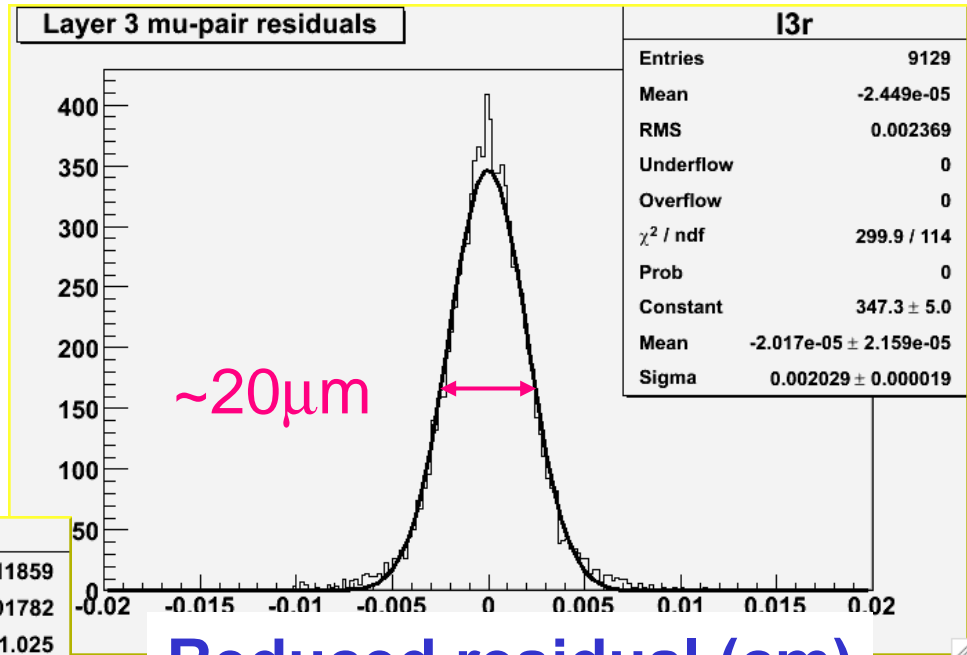
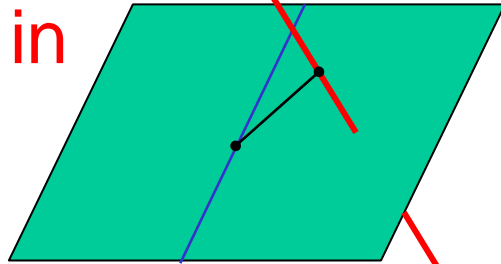


- **Sensor local coordinates**
 - ☞ $u \approx \phi$, $v \approx \text{beam}$, $w \approx \text{radial outward}$
- **6 alignment parameters**
 - ☞ Deviation WRT nominal
 - ☞ 3 translations $\delta u \delta w \delta v$
 - ☞ 3 (small) rotations $\alpha_u \alpha_w \alpha_v$
- **Total system has 6 redundant **Global alignment** DOFs**
- **Internal DOFs**
 - ☞ Charge drift asymmetry ($=0$)
 - ☞ Lorentz shift (estimated)
 - ☞ Non-planar distortions



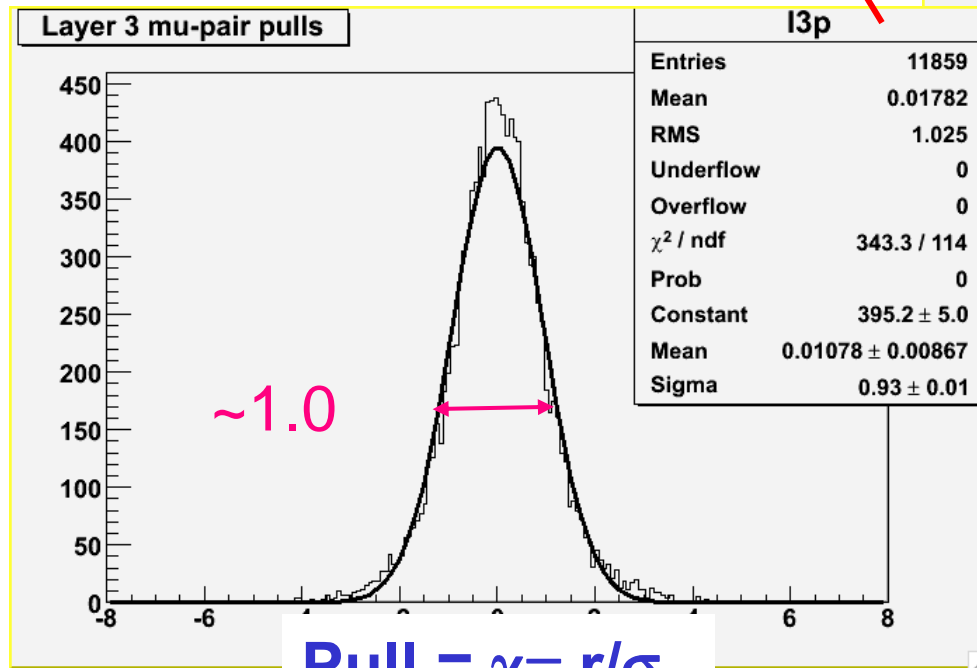
Track Residuals

Residual \equiv min. distance from track to hit in space



Reduced residual (cm)

- Reduced residual excludes the hit from the track fit



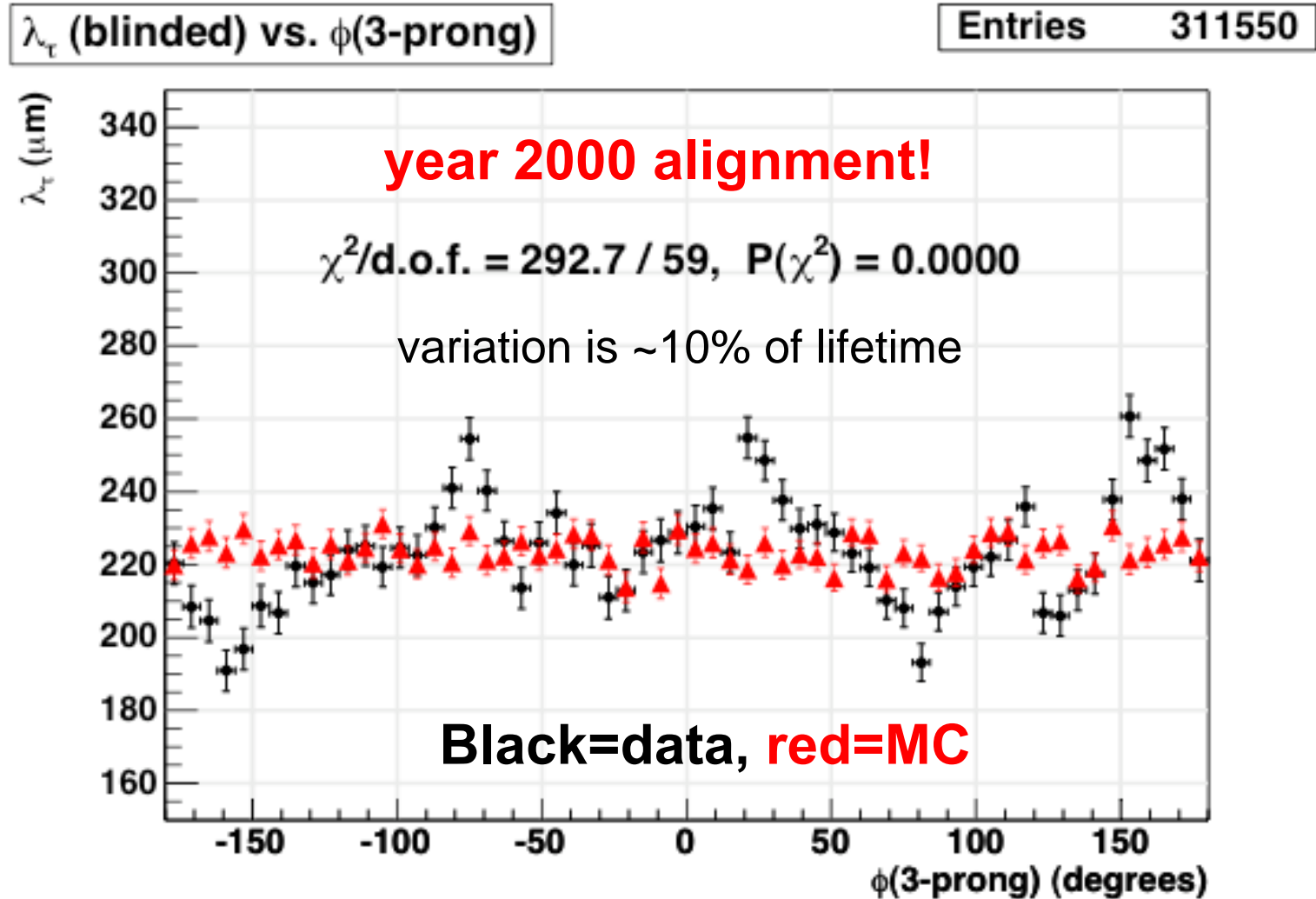
$\text{Pull} = \chi \equiv r / \sigma_r$

$$\chi^2 = \sum_{\text{residuals}} \left(\frac{r}{\sigma_r} \right)^2$$

BaBar Alignment History

- **BaBar design and construction: 1995→1999**
 - ☞ Alignment is considered (overlaps) but not studied
- **First data and commissioning in 1999**
 - ☞ Used Optical Survey wafer alignment + cosmics
- **1st Alignment procedure development 1999→2000**
 - ☞ Based on (primarily) $e^+e^- \rightarrow \mu^+\mu^-$ events
 - ☞ 1.5 FTE for development and operation
 - ☞ Procedure was manpower, cpu and data intensive
 - ☞ ~1 month turnaround time
 - ☞ **Visible systematic errors remained**
 - ☞ Early BaBar physics results were not compromised!
- **Complete rewrite of alignment procedure 2001→2002**
 - ☞ 3 FTE development effort over 1 year
 - ☞ Separate operations effort of 0.5 FTE
 - ☞ Designed coherently with a new **BaBar Data Model**
 - ☞ Deployed in 2002, we are still using this procedure today

BaBar τ lifetime in year 2000



Average τ
1-3 decay
distance

Alignment Design Principles

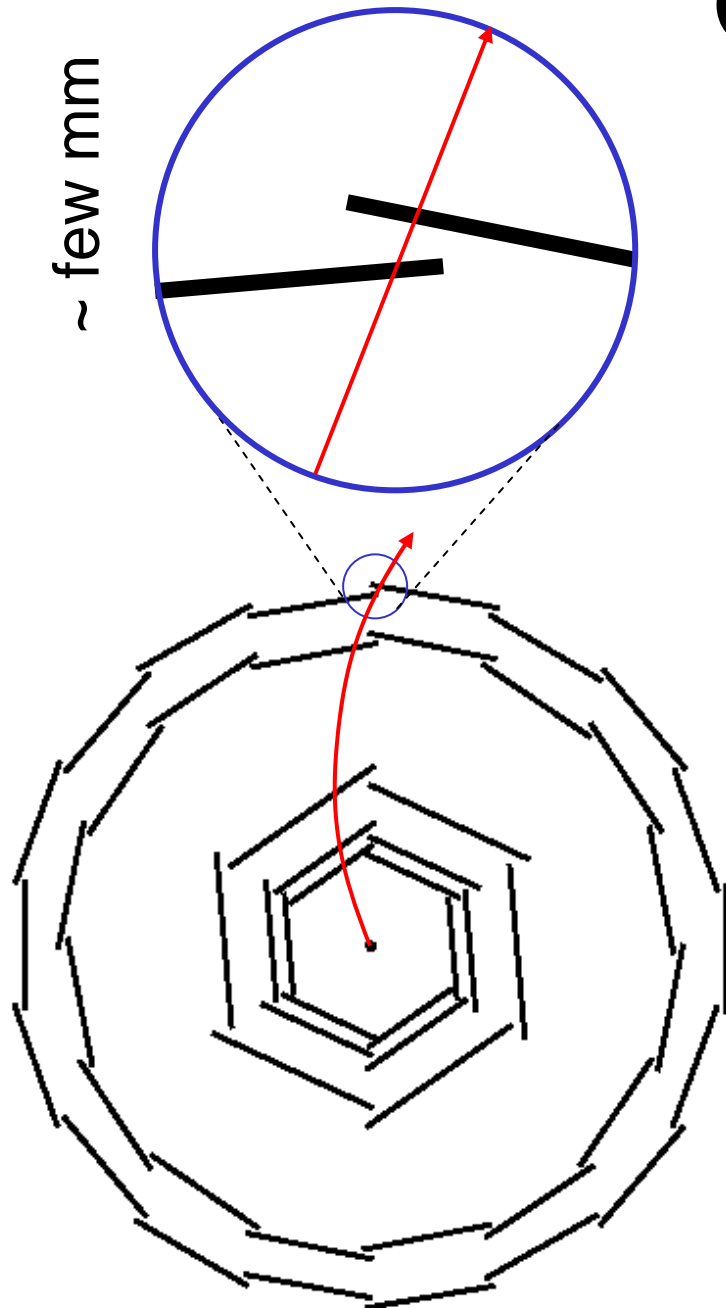
- **Combine complementary constraints**
 - ☞ Use lots of tracks to cover all wafer DOFs
 - ☞ Use different event triggers and track geometries to **balance systematic biases**
 - ☞ Relate wafers across the detector to **control global distortions**
 - ☞ Incorporate lab-based optical survey information
- **Select data to provide uniform constraints**
 - ☞ Make detector coverage more uniform
 - ☞ Select events uniformly over (short) time period
 - ☞ Equilibrate statistical errors
 - ☞ Minimize **statistical correlations** between wafers

Global Distortions

- Small relative changes between adjacent wafers that add up coherently across the detector
 - ☞ Residuals work 'locally'
- **Can introduce significant physics bias**
- Choose alignment constraints which control these

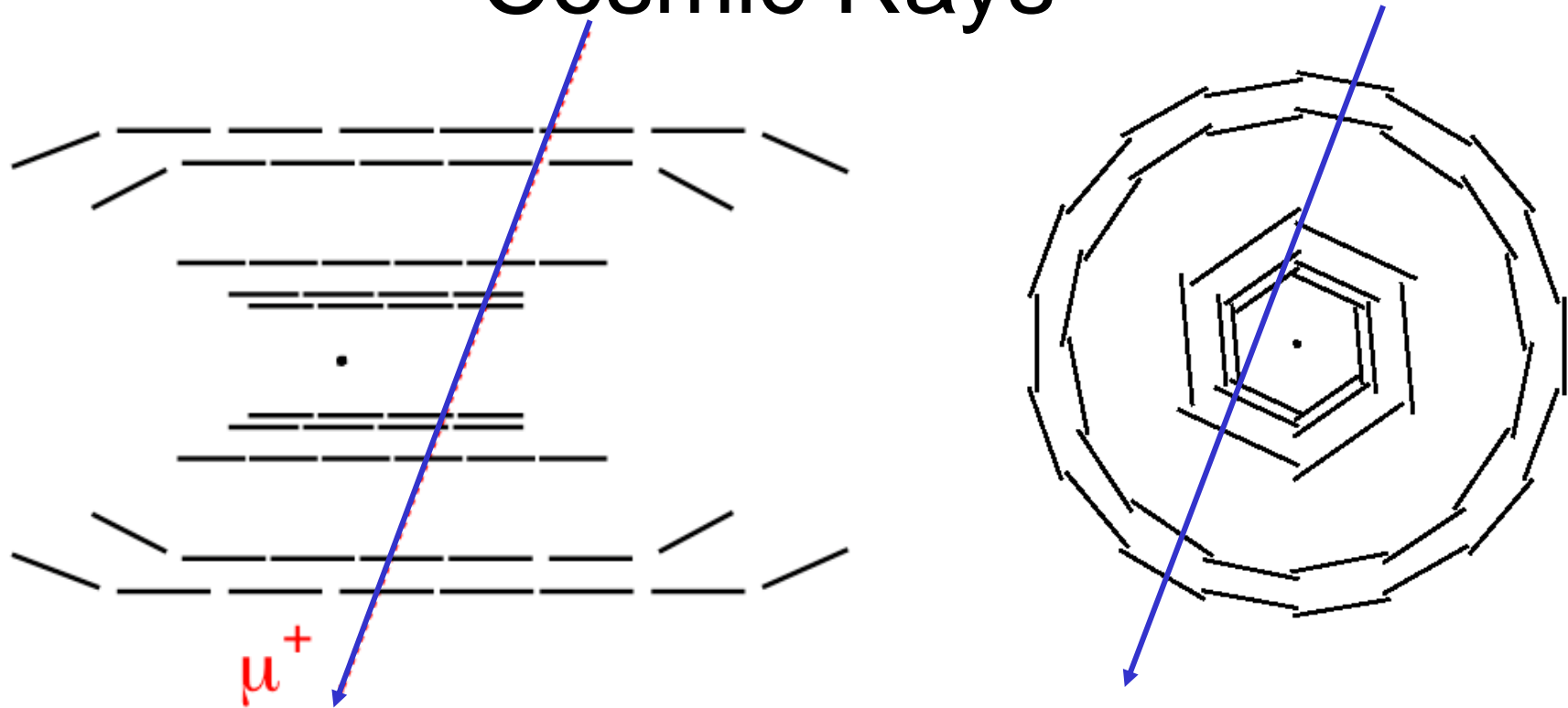
	ΔR	$\Delta\phi$	ΔZ
R	Radial expansion (distance scale)	Curl (charge asymmetry)	Telescope (COM boost)
ϕ	Elliptical (vertex mass)	Clamshell (vertex displacement)	Skew (COM energy)
Z	Bowing (COM energy)	Twist (CP violation)	Z expansion (distance scale)

Overlaps



- Active Si overlap between adjacent wafers in the same layer
- Small gap between overlapping wafers
 - ☞ Constrains adjacent wafers
 - ☞ **Not as effective in hex geometry**
- Overlaps cumulatively provide a **circumference constraint**
 - ☞ Relies on precise knowledge of wafer size
 - ☞ Constrains *radial expansion, clamshell distortions*
- **Small fraction of tracks**
 - ☞ Between 1% and 3%

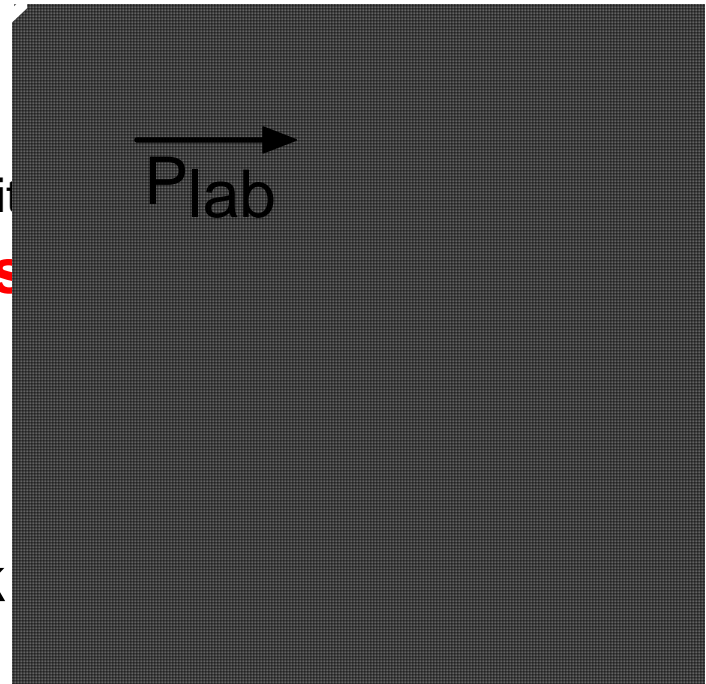
Cosmic Rays



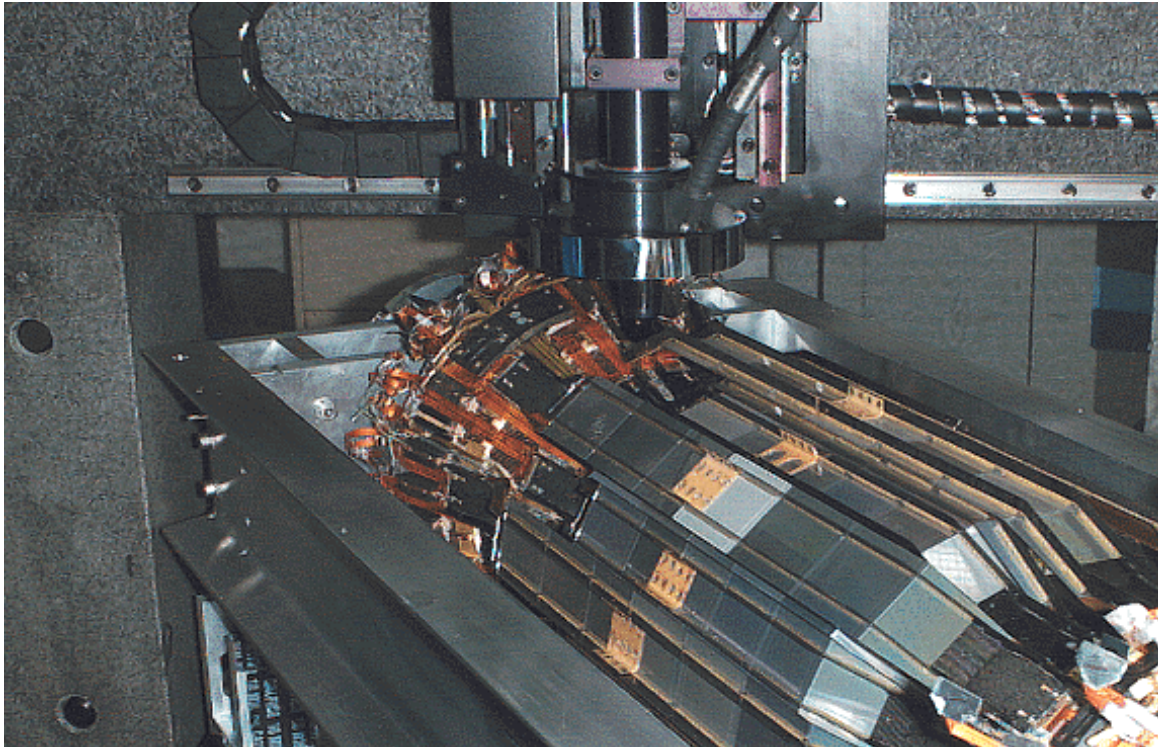
- High-momentum tracks ($> 1\text{Gev}$)
- Relates opposite side wafers \Rightarrow constrains *telescope distortion*
- Off-axis \Rightarrow constrains *twist, elliptical distortions*
- Low rate, non-uniform illumination

Pair Fit

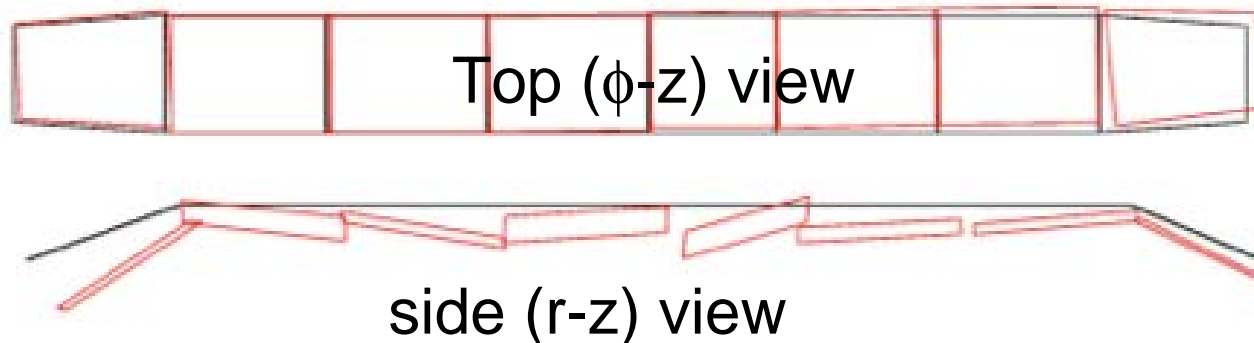
- Fit 2 tracks from $e^+e^- \rightarrow \mu^+\mu^-$ (and $e^+e^- \rightarrow e^+e^-$) simultaneously
 - ☞ Constrained to a common origin
 - ☞ Constrain Σ momentum to 'known' CM 4-momentum
 - ☞ Scale errors for beam uncertainties
 - ☞ Implemented in the BaBar Kalman track fit
- Provides **pair-constrained residuals**
 - ☞ Not just a mass-constrained vertex fit!
- Constrains *curl, bowing, and skew distortions*
- Technique can work for other track pairs (ie $\psi \rightarrow \mu^+\mu^-$)
- **Depends on initial beam parameter knowledge**



Optical Survey



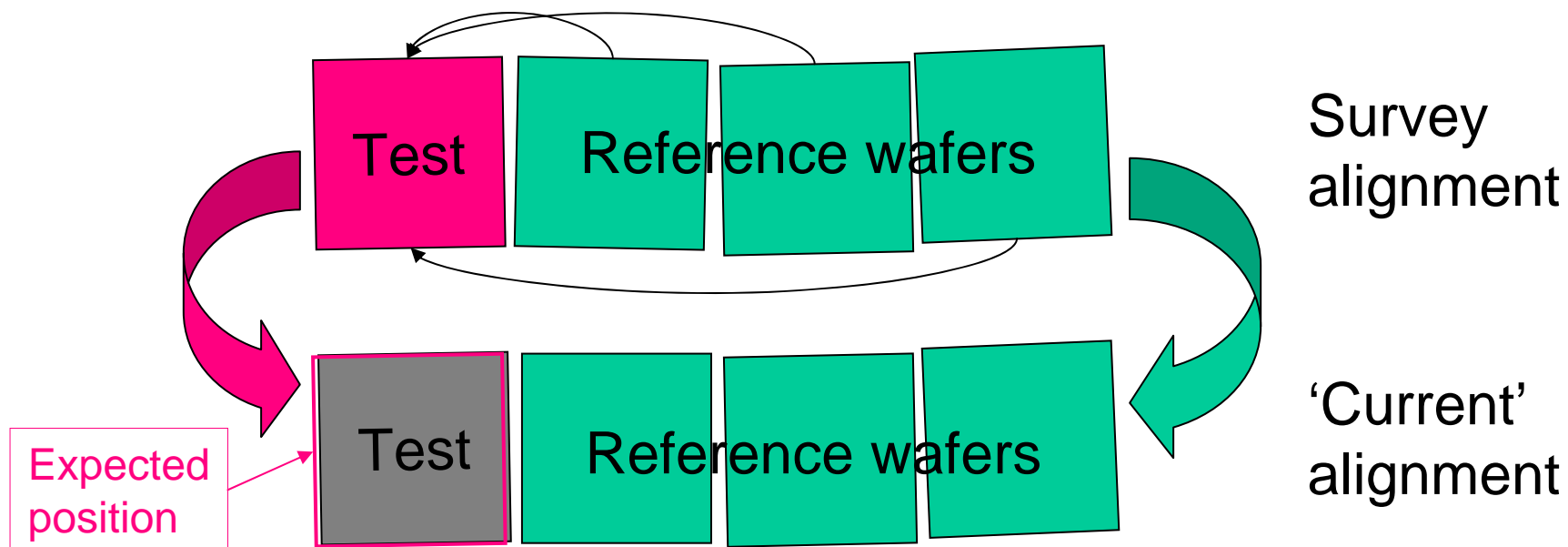
- Use combination of Module Survey (lab bench) + Assembly Survey
- Constraint of wafers within a module complementary to tracks
- Constrains Z expansion distortion



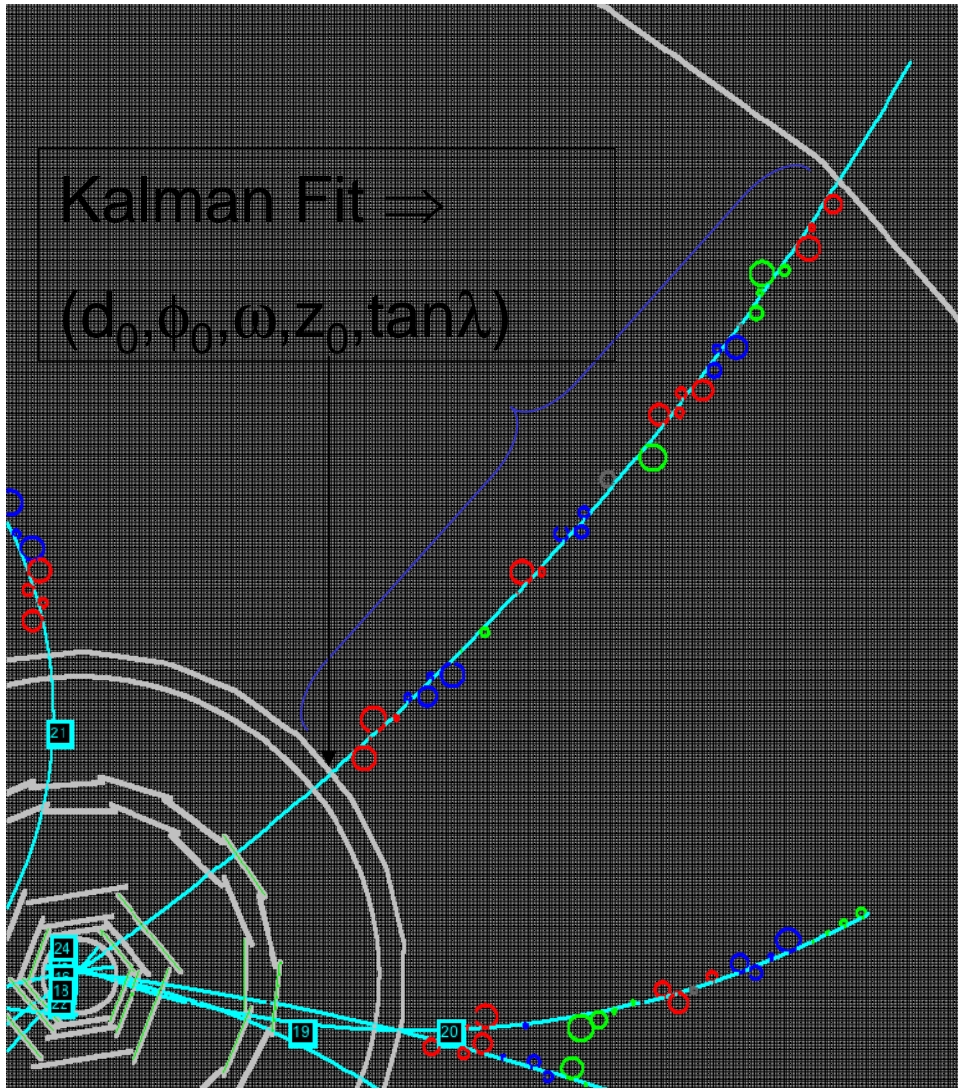
(distortions X 50)

Survey Constraint

- Compute 'survey to current' transform using reference wafers
 - ☞ Minimize difference between position of fiducials on the wafers
- Predict position of 'test' wafer position in 'current' alignment
- Compute $\Delta\chi^2$ = difference between current and survey position
 - ☞ **Multiply out-of-plane errors X 10** to accommodate motion since survey
- Add survey $\Delta\chi^2$ to track residual χ^2

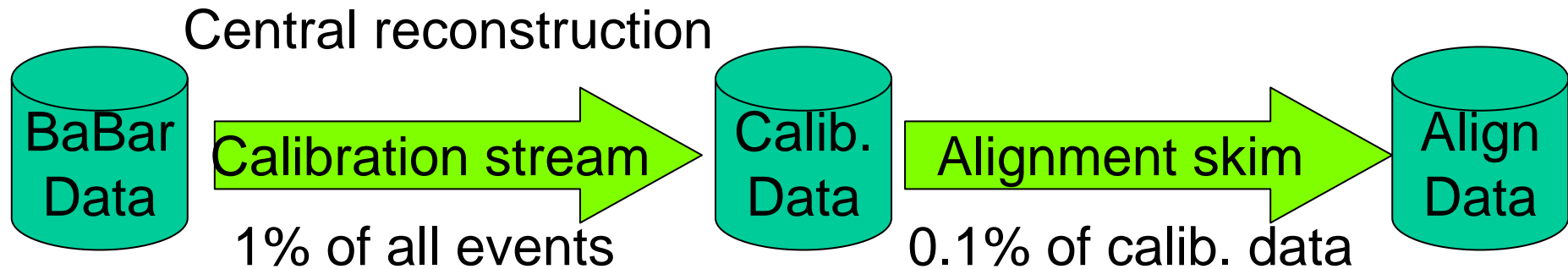


Outer Tracking Constraint



- Tracks are split at boundary
 - ☞ Each half fit separately
- Outer track fit used to **constrain** the inner track fit
 - ☞ Can select which parameters to propagate
 - ☞ Improves precision while controlling propagation of outer tracker systematics
 - ☞ Standard feature of BaBar Kalman track fit
- μ -pair + cosmic (high p)
 - ☞ Constrain only curvature
- Isolated high-P hadrons
 - ☞ Constrained to full outer track fit (5 parameters)
- Keeps relative (global) alignment from **drifting**

Alignment Data Reduction

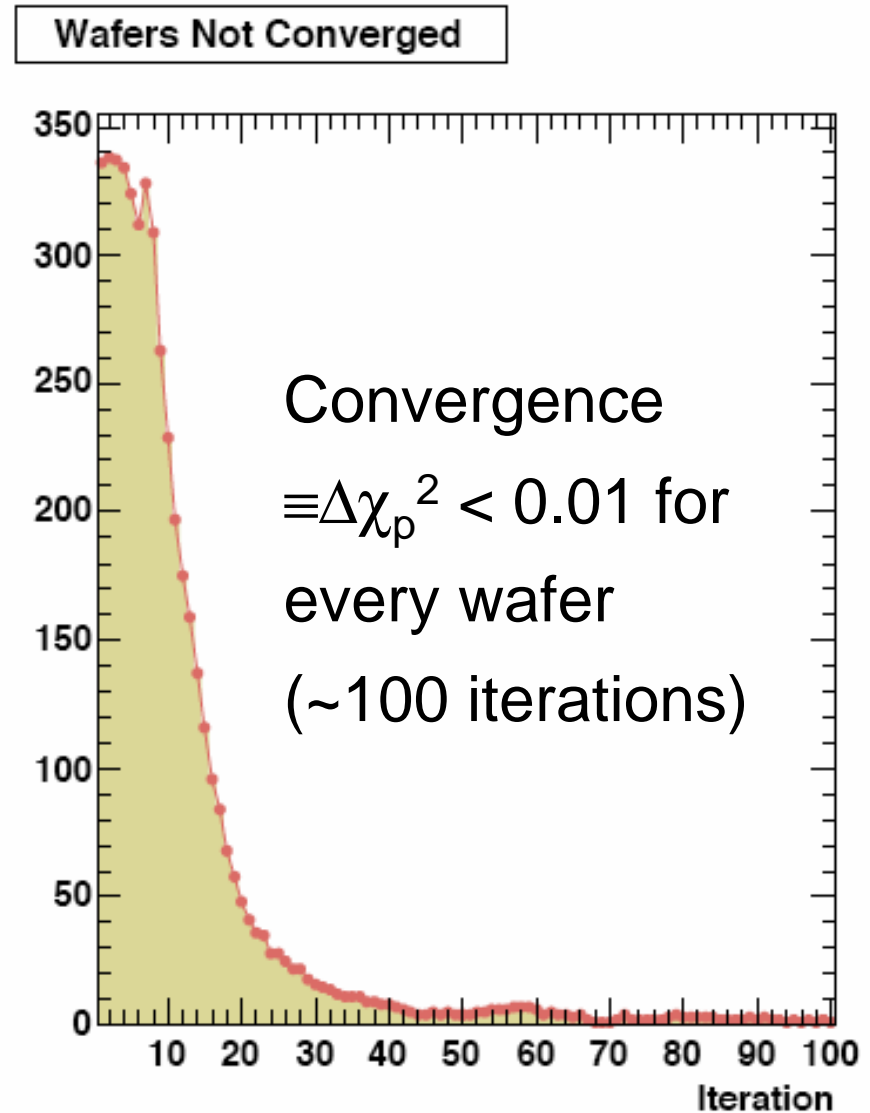
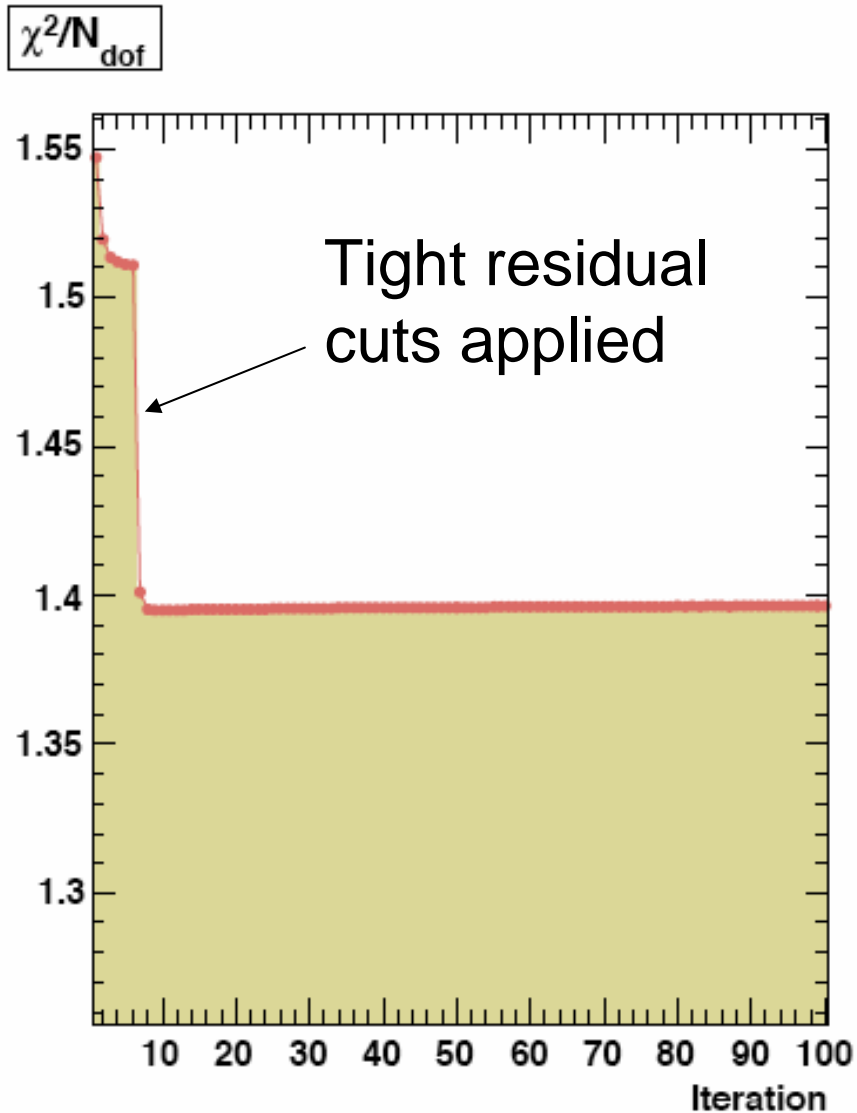


- **A dedicated sample is selected during reconstruction**
 - ☞ μ pairs, cosmics, prescaled hadronic events with high P tracks, ...
 - ☞ **Written to a dedicated stream (file)**
- **From ~ 2 days accumulation we extract an alignment sample**
 - ☞ **Events are prescaled by type and polar angle coverage**
 - ☞ Timescale driven by **cosmics**
 - ☞ **Only selected tracks are kept, all other data is removed**
 - ☞ Outer tracker info is kept as a **fit constraint**, reduces track size by 1/3
 - ☞ **Hits are prescaled for uniform coverage, selected hits are flagged**
 - ☞ Defines fixed selection of hits used across iterations
 - ☞ Greatly reduces **statistical correlation** between wafers
- **Customizations are built in to the BaBar Data Model**

Alignment Iteration

- Iteration factorizes the alignment problem
 - ☞ No need for huge matrix inversion (6X6 vs 1440X1440)
 - ☞ No need to compute distant derivatives
- 1 iteration = loop over all wafers
- Minimize $\Sigma \chi^2$ (closed form) for each wafer
 - ☞ Sum $\Delta\chi^2$ + associated derivatives wrt alignment parameters
 - ☞ Solve for the change in this wafers alignment parameters
- **Wafer positions are updated only after a full iteration**
 - ☞ Parallelizable (if wall-clock time were an issue)
- Initialize using previous, survey, nominal, **test configuration**, ...
- **Tighten residual cuts** after partial convergence
 - ☞ Reduces the effect of **outliers** without biasing alignment
 - ☞ Requires re-writing alignment dataset (reflagging hits)
- Convergence \equiv when wafers stop moving
 - ☞ $\Delta\chi_p^2 \equiv (\Delta P/\sigma P)^2/6 < 0.01$ for every wafer in 1 iteration
 - ☞ ~100 iterations, <24 hours real-time (single processor)

Alignment Convergence



Alignment Operations

- **Alignment computed every 2 weeks (or as necessary)**
 - ☞ Fully automated (except validation!)
 - ☞ 2-day turnaround
 - ☞ Upload to database only if changes are significant (by a human)
- **So far we have ~40 alignment periods, separated by**
 - ☞ Detector interventions
 - ☞ **Humidity effects**
 - ☞ Carbon fiber is hygroscopic
- **Detector has been stable for the past ~2 years**

History of outer layer
relative radial position
vs Z for 2001→2003

http://dnbmac3.lbl.gov/~brownd/alignment/SvtChange_dr

Global Distortion Tests

- **Validate the procedure against global distortions**
 - ☞ Small, coherent relative wafer displacement
- **Use undistorted MC sample composed as data**
 - ☞ Cosmics, μ -pairs, hadronic decays, ...
- **Align starting with a **distorted initial condition****
 - ☞ **50 μm** scale, smooth dependence on either R, ϕ , or Z

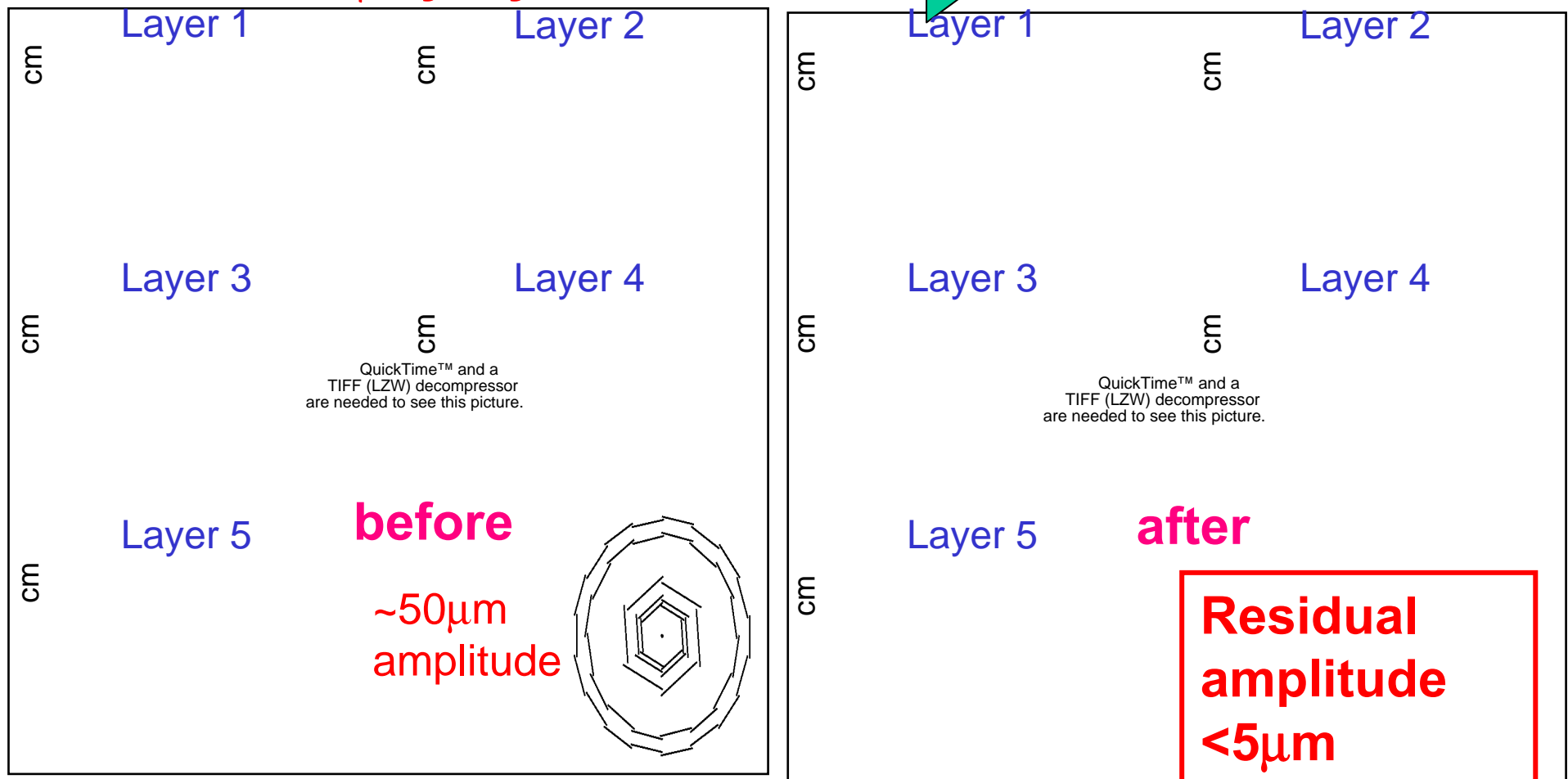
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ϕ	Elliptical (vertex mass)	Clamshell (vertex displacement)	Skew (COM energy)
Z	Bowing (COM energy)	Twist (CP violation)	Z expansion (distance scale)

Example: Elliptical Distortion

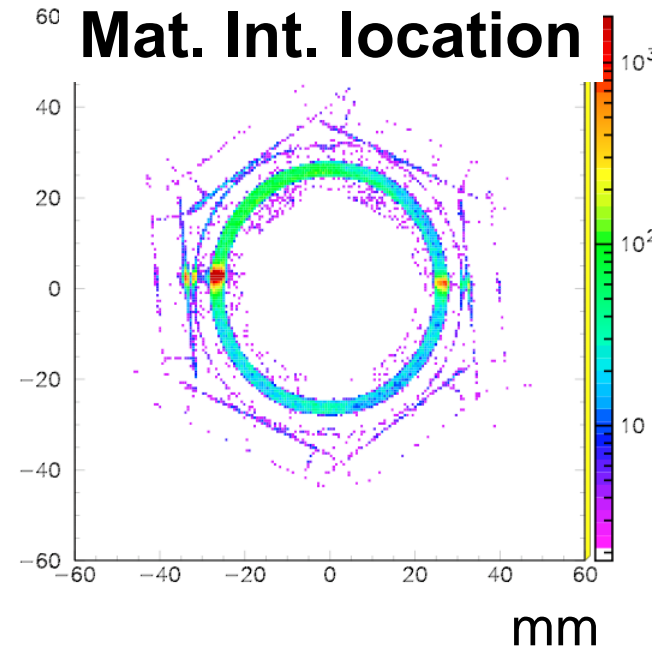
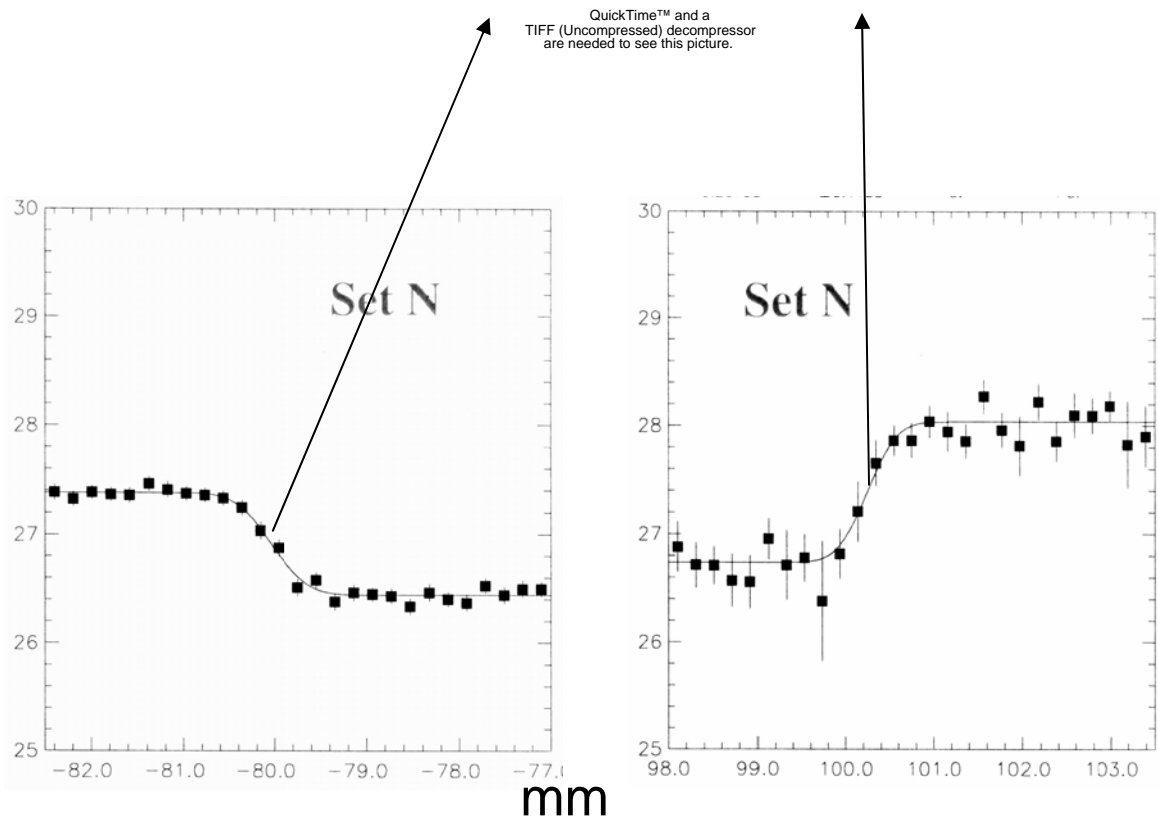
Apply 0.1% elliptical distortion ($\sim 50\mu\text{m}$ amplitude in layer 5)

ΔR vs ϕ by layer

100 Iterations

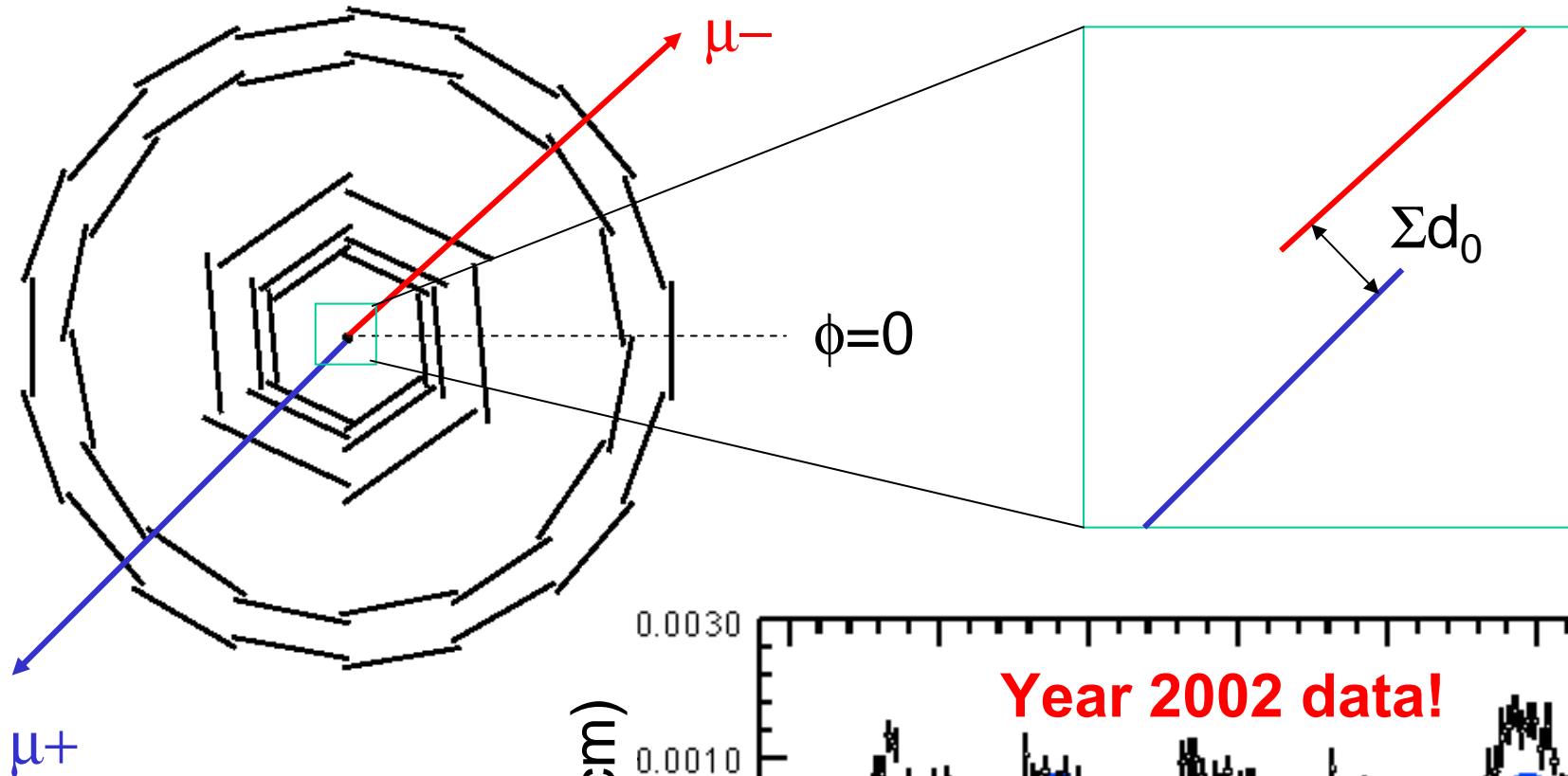


Z Scale Validation

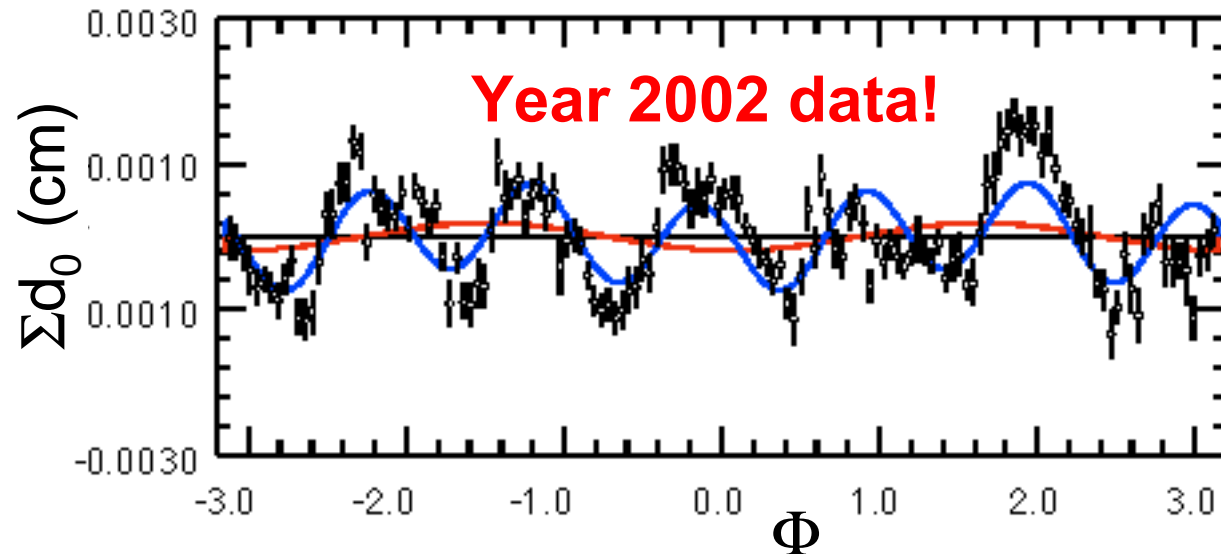


Tracks from material interactions agree with bench measurements to $0.03 \pm 0.05 \%$

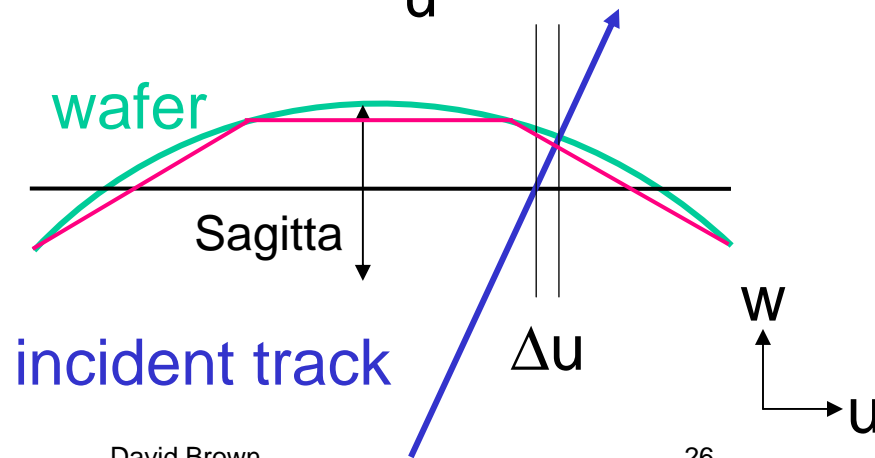
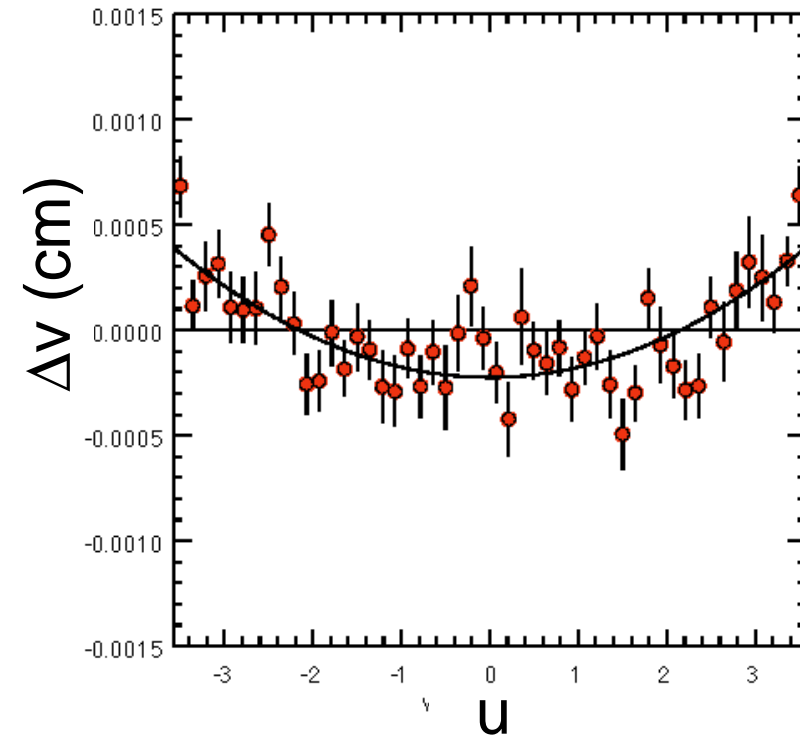
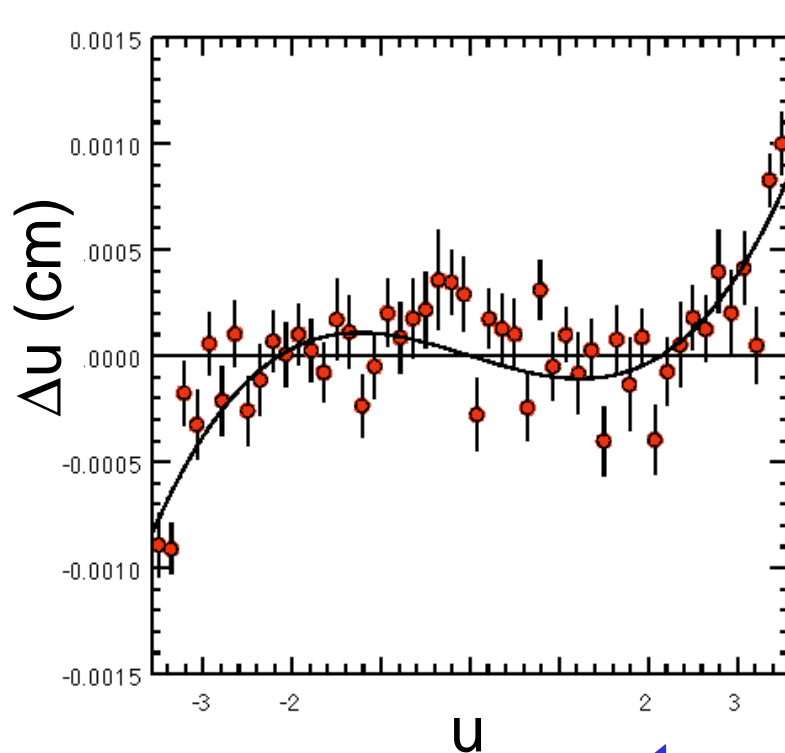
μ -pair miss distance



After alignment,
we observed a
strong 6-fold
symmetry



The Explanation: Wafer Bowing



- **Fit wafer sagitta**

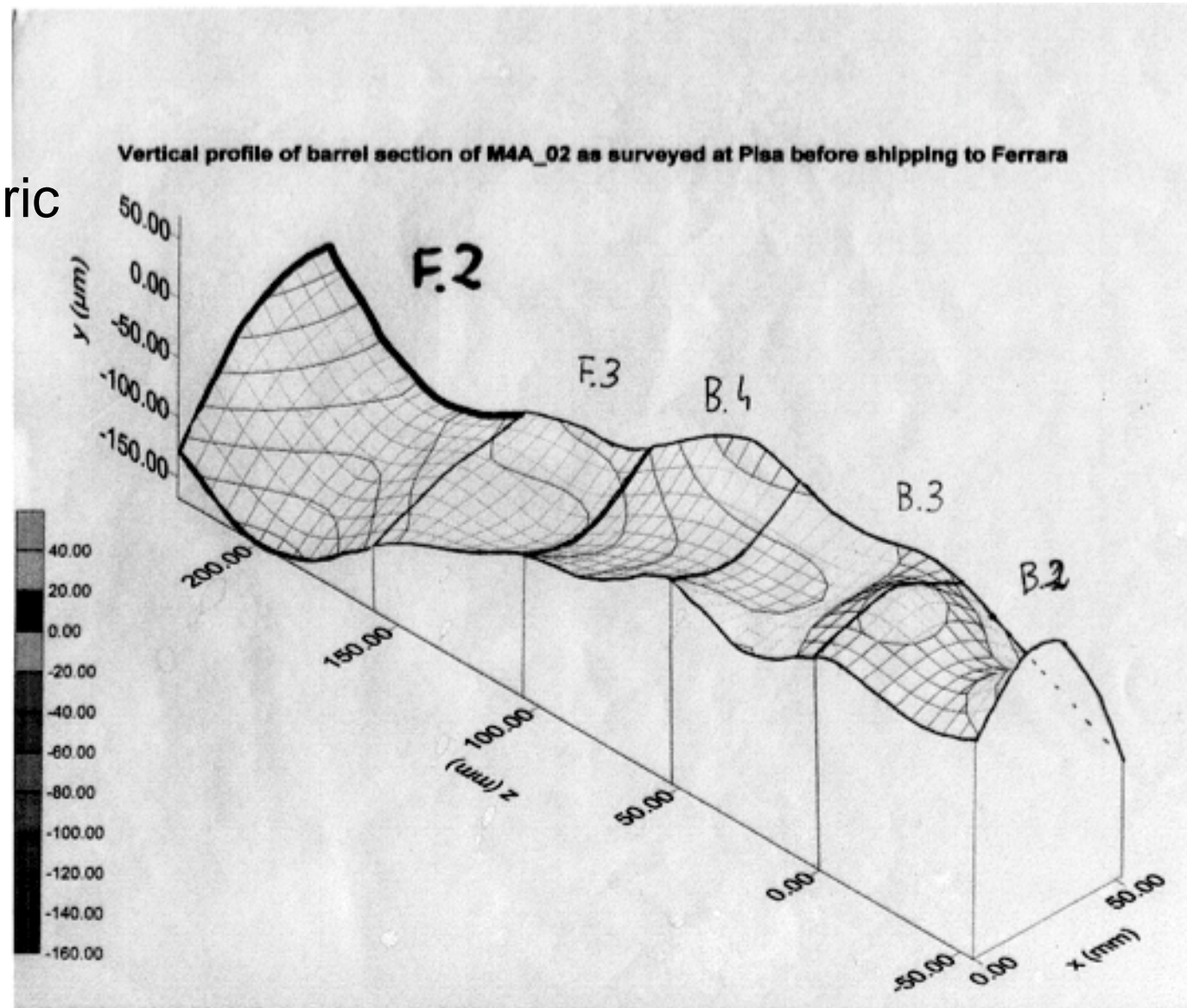
- ☞ Use both u and v residuals
- ☞ Iterate with normal alignment
- ☞ Mostly affects layers 1,2 + 3

- **Correct in reconstruction**

- ☞ Model v strips as 3 linear pieces

Wafers are not planes (or cylinders)!

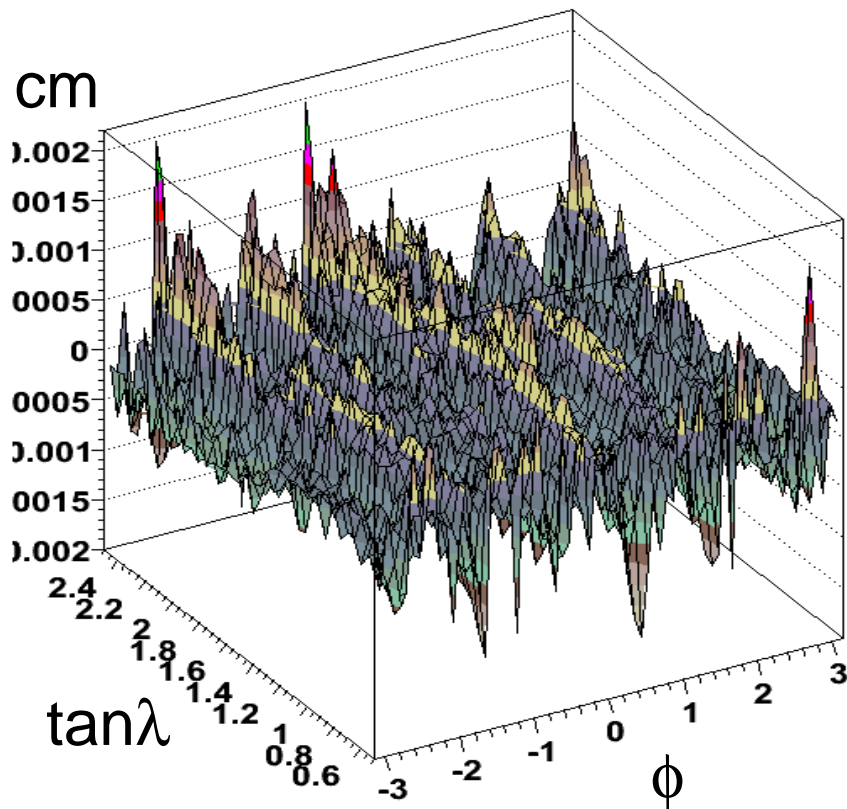
3-D Interferometric survey of 1 module before installation



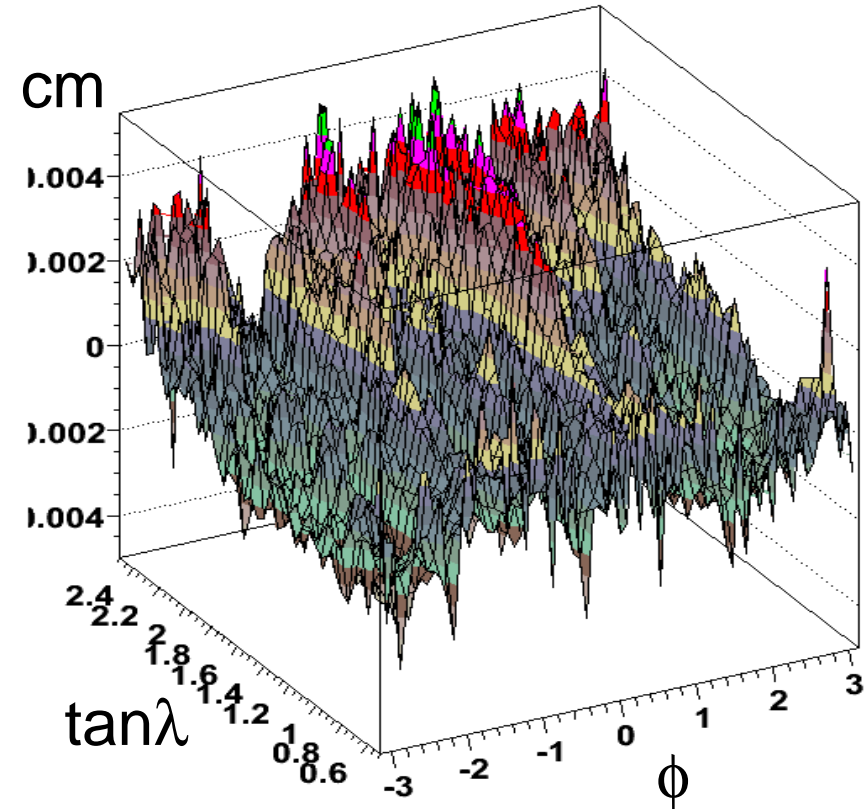
μ -pair Miss Distance

- **Average** variation of $<2 \mu\text{m}$ in Σd_0 , $<10 \mu\text{m}$ in Δz_0
- With **10X standard alignment sample**, structure is seen
 - ☞ More general non-planar distortions

Σd_0 vs ϕ and $\tan\lambda$



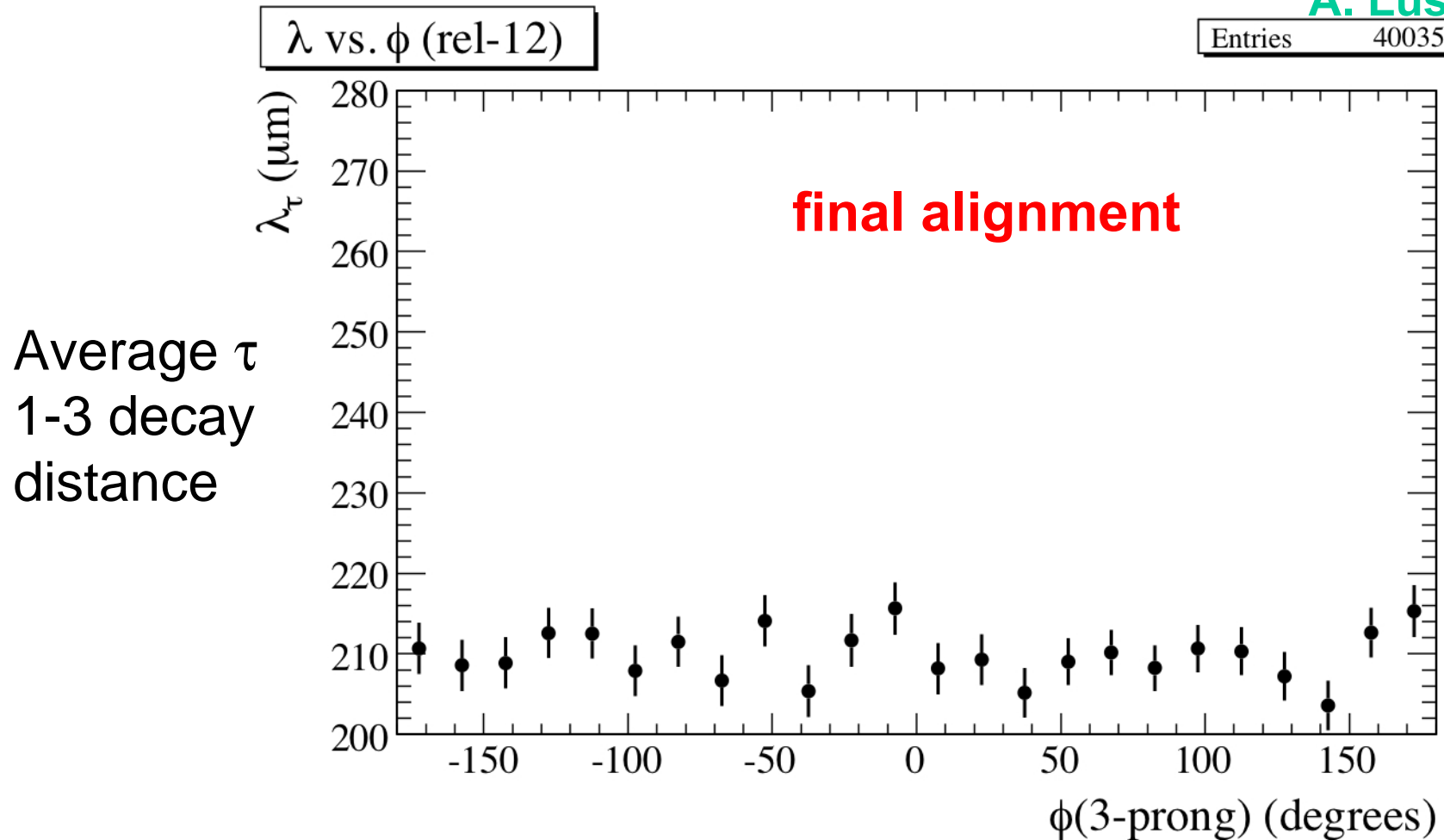
Δz_0 vs ϕ and $\tan\lambda$



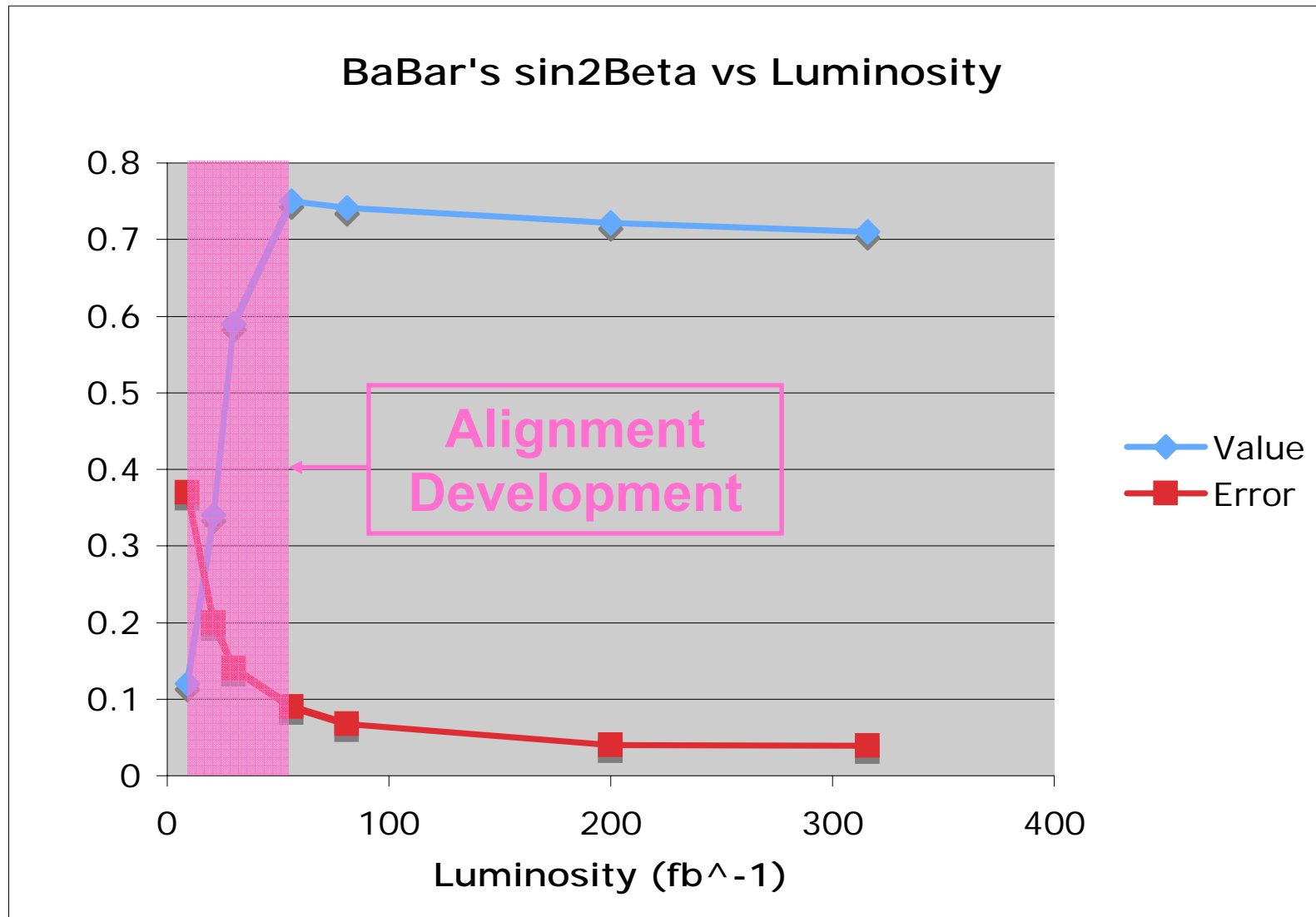
τ Lifetime Revisited (2005)

- “The peak to peak variation of the reconstructed decay length vs ϕ is consistent with just natural lifetime fluctuations.”

A. Lusiani



BaBar's $\sin 2\beta$ History



Si Alignment Lessons Learned

- **Detector Design**
 - ☞ Prioritize material, resolution, **stability**
 - ☞ **Simulate alignment to optimize overlap, layer coverage, ...**
- **Construction**
 - ☞ **Make Lab-bench measurements of all components**
 - ☞ Survey aggregate sensor units (module, ladder, ...) **in 3-D**
 - ☞ Measure material properties of all active-region components
 - ✦ Si thickness, material of hybrids, location of masking, ...
 - ☞ **Assembly survey as a cross check (if practical)**
- **Software Design**
 - ☞ **Data model support for alignment**
 - ☞ Custom event selection, hit flagging, parameter constraints
 - ☞ **Kalman track fit alignment-specific features**
 - ☞ Pair fit, parameter constraint
 - ☞ **Allocate adequate manpower to alignment development**
- **Operations**
 - ☞ **Allocate dedicated processing and storage for alignment**

Lessons Learned (continued)

● Procedure

- ☞ **Accurately represents the true DOFs**
 - ☞ Consider **non-planar distortions!**
- ☞ **Use complementary event types and external constraints**
- ☞ **Prescale events** to create a uniform, consistent data sample
- ☞ **Prescale and flag hits**
 - ☞ Reduce statistical correlations
 - ☞ Consistent and stable χ^2 calculations
- ☞ **Validate against realistic distortion scenarios**
- ☞ **Don't get hung up on mathematical details**
 - ☞ Any well-behaved, additive measure will probably work
 - ☞ Any minimization technique that converges will probably work

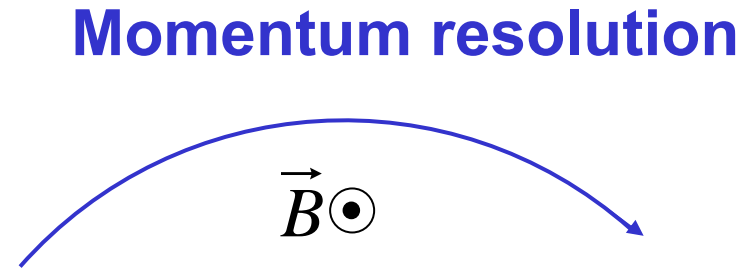
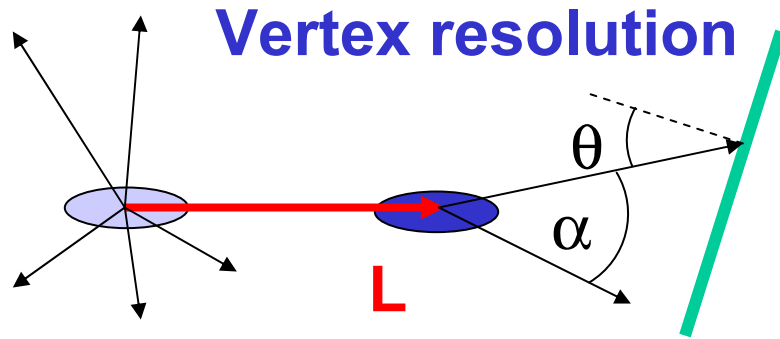
● Physics Use

- ☞ **Plan for providing an early (preliminary) alignment**
- ☞ **Provide analysts with a misalignment estimate**

● Be prepared for the unexpected!

Backup Slides

How Well To Align?



$$\delta L \approx \frac{\frac{\delta_x}{0.7\sqrt{N}} \oplus \frac{R_{\min} 14 \text{ MeV} \sqrt{\Delta/X_0}}{P \sin^{3/2} \theta}}{\alpha}$$

$$\frac{\delta P_t}{P_t^2} \approx \frac{\delta_x \sqrt{720/(N+5)}}{0.3L \int \vec{B} \times d\vec{L}} \oplus O(1/P)$$

- **Statistical (< 5% from alignment)**

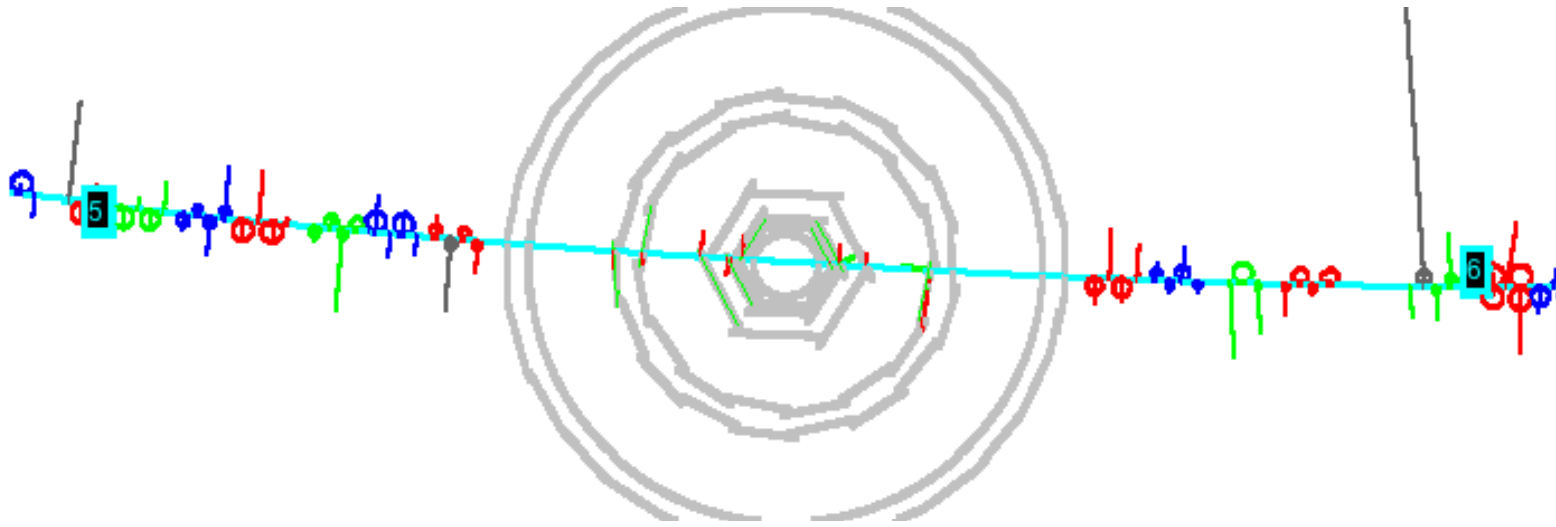
- ☞ $\delta_{\text{in-plane}} < \delta_x/3$

- ☞ $\delta_{\text{out-of-plane}} \sim \delta_{\text{in-plane}}/\theta$

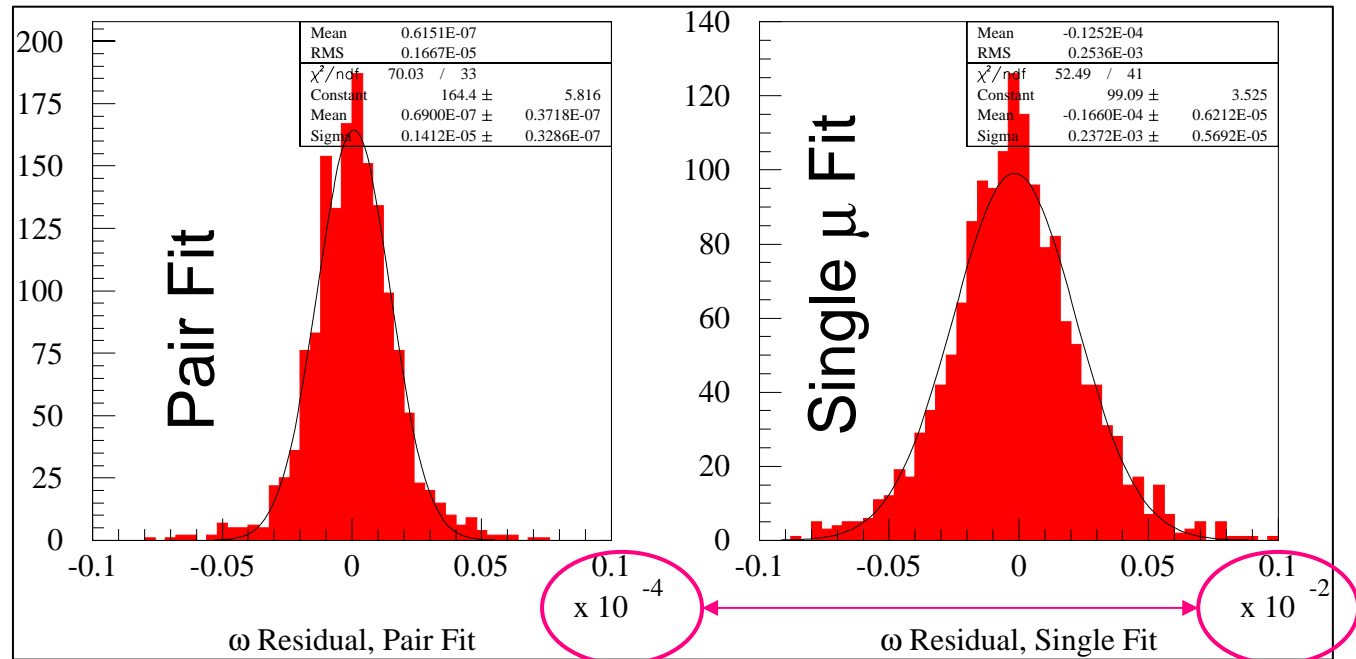
- **Systematic (no visible biases)**

- ☞ Roughly 3-times better than statistical *on average*

Pair Fit Results

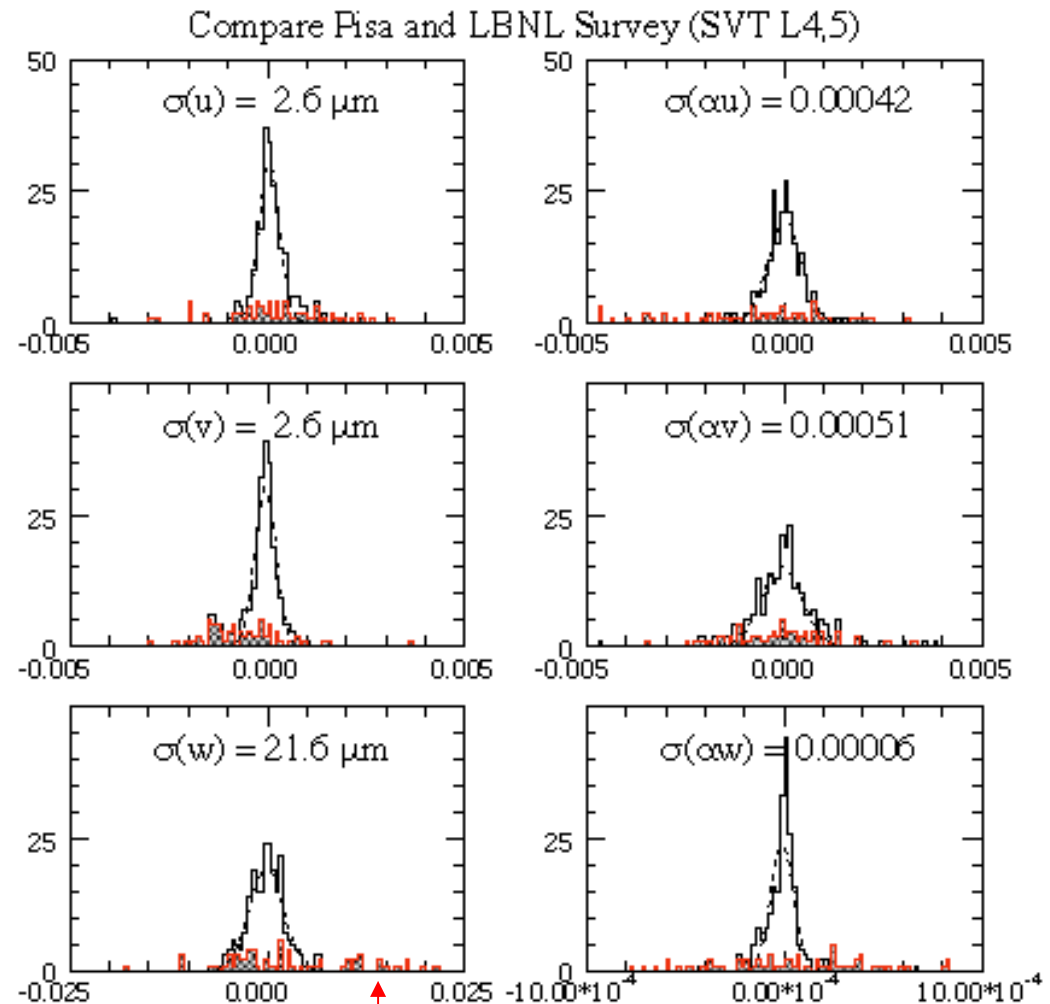
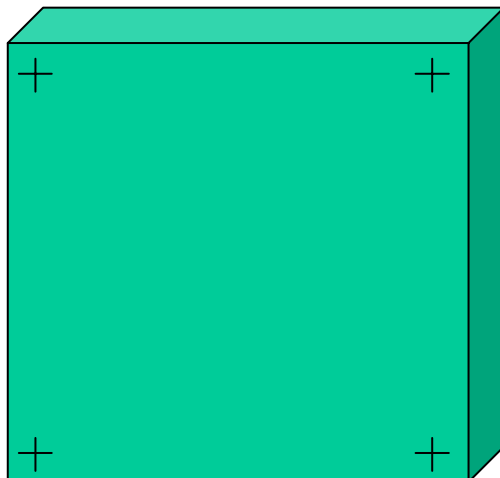


- **Curvature resolution improves >2 orders of magnitude!**
- **Constrains relative dip angle (through boost)**



Lab \Leftrightarrow Assembly Survey Comparison

- Compare at fiducials
 - ☞ Remove global DOFs
- $<3\mu\text{m}$ in plane
 - ☞ $\sim 1\mu\text{m}$ statistical
- $\sim 20\mu\text{m}$ out of plane
 - ☞ $\sim 10\mu\text{m}$ statistical
- Average these when used in alignment



Lampshade wafers

Event and Hit Prescaling

normal

μ -pair

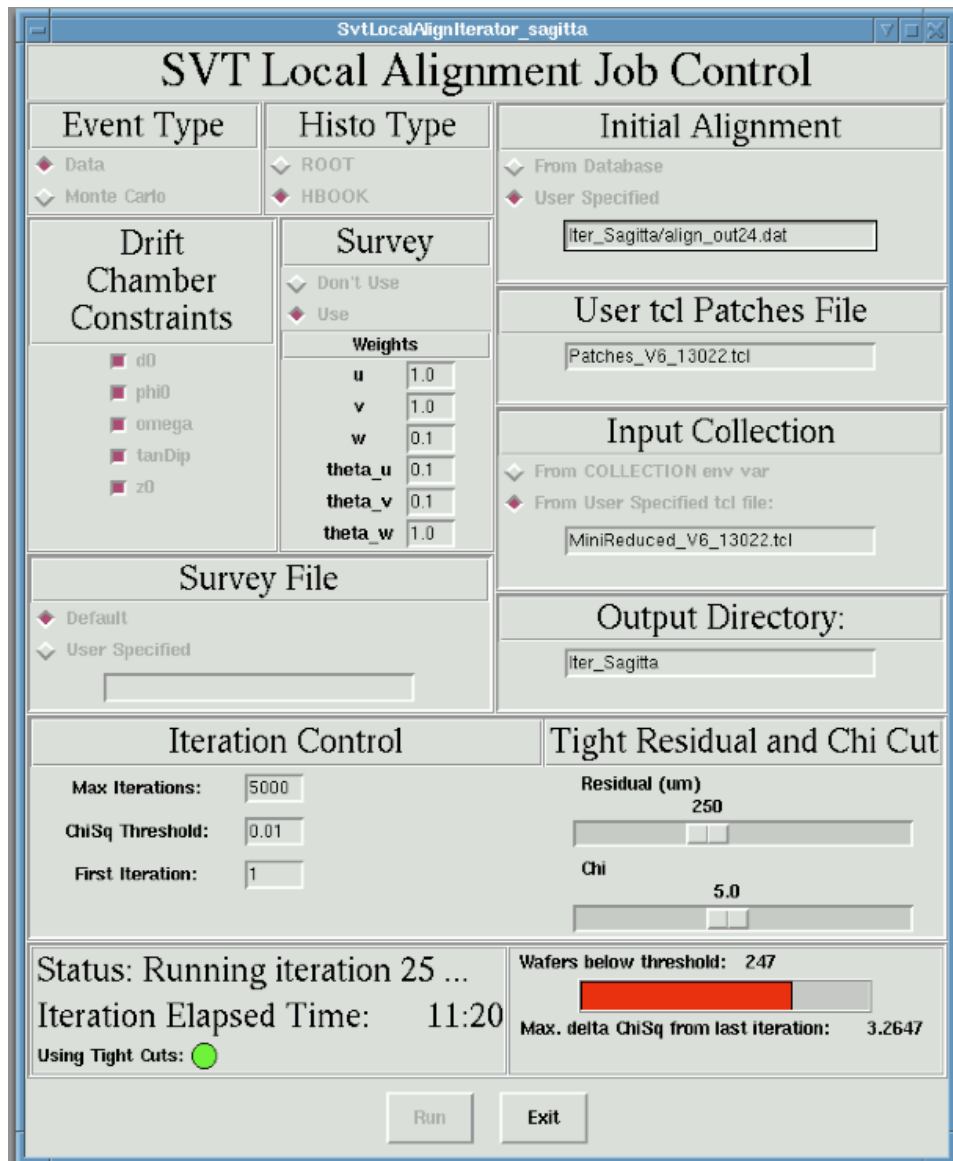
cosmics

Quick
TIFF (Uncompr
are needed t

overlaps

- Prescale events by category
 - ☞ $\mu^+\mu^-$, cosmic, overlap track, ...
- Prescale hits on each track
 - ☞ Uniformly populate wafers
 - ☞ Sample data period uniformly
 - ☞ Balance different event types
 - ☞ **Eliminate statistical correlation between wafers**
- Flag selected hits
 - ☞ The exact same hits are used to calculate χ^2 every iteration
 - ☞ Can (anti-)select hits when validating
 - ☞ **Written into the data**
- Overlaps are under-populated
 - ☞ 1.5% nominal overlap in layer 4

Iteration Control



- Iteration is controlled by tcl scripts with tk window
 - ☞ Parameters can be adjusted
 - ☞ Job progress is monitored
- Typical job converges in ~100 iterations and takes ~ 24 hours

μ -pairs after Curvature Correction

- **Average** distortion reduced to $\sim 2 \mu\text{m}$ in Σd_0 , $\sim 10 \mu\text{m}$ in Δz_0
- With 10X data, structure is seen!

QuickTime™ and a
TIFF (Uncompressed) decompressor
are needed to see this picture.

Σd_0

Δz_0

Aleph VDET bonding error

